

MEASUREMENT REPORT

LTE

Applicant Name:

Samsung Electronics Co., Ltd.
129, Samsung-ro,
Yeongtong-gu, Suwon-si
Gyeonggi-do, 16677, Korea

Date of Testing:

9/27 - 10/12/2017

Test Site/Location:

PCTEST Lab. Columbia, MD, USA

Test Report Serial No.:

1M1709270258-03.A3L

FCC ID:

A3LSMJ250F

APPLICANT:

Samsung Electronics Co., Ltd.

Application Type:

Certification

Model:

SM-J250F/DS

Additional Model:

SM-J250F

EUT Type:

Portable Handset

FCC Classification:

TNE (Licensed Non-Broadcast Transmitter Held to Ear)

FCC Rule Part(s):

22 & 27

Test Procedure(s):

ANSI/TIA-603-E-2016, KDB 971168 D01 v02r02

Test Device Serial No.:

identical prototype [S/N: 49176, 48368, 49135]

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.



Randy Ortanez
President

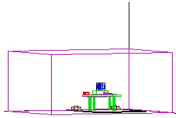


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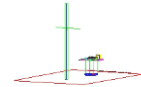
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FCC Part 22 & 27



Mode	FCC Rule Part	Tx Frequency (MHz)	ERP		EIRP		Emission Designator	Modulation
			Max. Power (W)	Max. Power (dBm)	Max. Power (W)	Max. Power (dBm)		
LTE Band 5	22H	824.7 - 848.3	0.149	21.73	0.244	23.88	1M09G7D	QPSK
LTE Band 5	22H	824.7 - 848.3	0.093	19.69	0.153	21.84	1M08W7D	16QAM
LTE Band 5	22H	825.5 - 847.5	0.146	21.63	0.239	23.78	2M74G7D	QPSK
LTE Band 5	22H	825.5 - 847.5	0.109	20.37	0.179	22.52	2M72W7D	16QAM
LTE Band 5	22H	826.5 - 846.5	0.153	21.85	0.251	24.00	4M55G7D	QPSK
LTE Band 5	22H	826.5 - 846.5	0.094	19.73	0.154	21.88	4M53W7D	16QAM
LTE Band 5	22H	829 - 844	0.139	21.42	0.228	23.57	9M03G7D	QPSK
LTE Band 5	22H	829 - 844	0.111	20.44	0.182	22.59	9M01W7D	16QAM
LTE Band 7	27	2502.5 - 2567.5			0.205	23.12	4M57G7D	QPSK
LTE Band 7	27	2502.5 - 2567.5			0.167	22.24	4M53W7D	16QAM
LTE Band 7	27	2505 - 2565			0.206	23.14	9M01G7D	QPSK
LTE Band 7	27	2505 - 2565			0.158	21.99	9M01W7D	16QAM
LTE Band 7	27	2507.5 - 2562.5			0.198	22.96	13M5G7D	QPSK
LTE Band 7	27	2507.5 - 2562.5			0.155	21.89	13M5W7D	16QAM
LTE Band 7	27	2510 - 2560			0.179	22.53	18M0G7D	QPSK
LTE Band 7	27	2510 - 2560			0.128	21.07	18M0W7D	16QAM
LTE Band 38	27	2572.5 - 2617.5			0.290	24.63	4M54G7D	QPSK
LTE Band 38	27	2572.5 - 2617.5			0.192	22.84	4M53W7D	16QAM
LTE Band 38	27	2575 - 2615			0.209	23.20	9M03G7D	QPSK
LTE Band 38	27	2575 - 2615			0.131	21.19	9M02W7D	16QAM
LTE Band 38	27	2577.5 - 2612.5			0.306	24.86	13M6G7D	QPSK
LTE Band 38	27	2577.5 - 2612.5			0.219	23.40	13M5W7D	16QAM
LTE Band 38	27	2580 - 2610			0.189	22.76	17M9G7D	QPSK
LTE Band 38	27	2580 - 2610			0.110	20.42	17M9W7D	16QAM

EUT Overview

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 PCTEST Test Location

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.

- PCTEST is an ISO 17025-2005 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISSED Standards (RSS)."
- PCTEST facility is a registered (22831) test laboratory with the site description on file with ISSED.

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMJ250F**. The test data contained in this report pertains only to the emissions due to the EUT's LTE function.

2.2 Device Capabilities

This device contains the following capabilities:

850 GSM/GPRS/EDGE, 850 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, Bluetooth (1x, EDR, LE)

2.3 Test Configuration

The EUT was tested per the guidance of ANSI/TIA-603-E-2016 and KDB 971168 D01 v02r02. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

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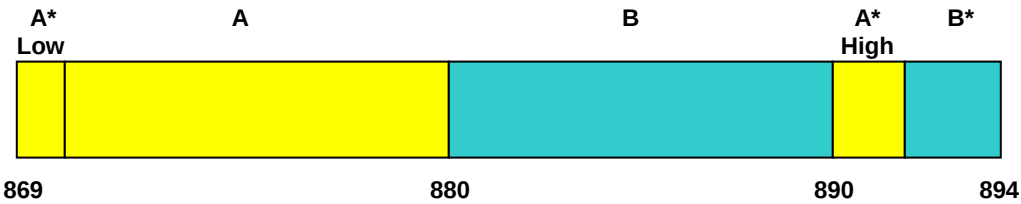
3.0 DESCRIPTION OF TESTS

3.1 Measurement Procedure

The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-E-2016) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v02r02) were used in the measurement of the EUT.

3.2 Cellular - Base Frequency Blocks

§22.905



BLOCK 1: 869 – 880 MHz (A* Low + A)

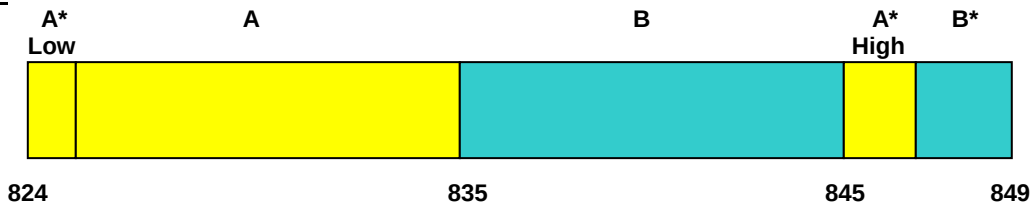
BLOCK 2: 880 – 890 MHz (B)

BLOCK 3: 890 – 891.5 MHz (A* High)

BLOCK 4: 891.5 – 894 MHz (B*)

3.3 Cellular - Mobile Frequency Blocks

§22.905



BLOCK 1: 824 – 835 MHz (A* Low + A)

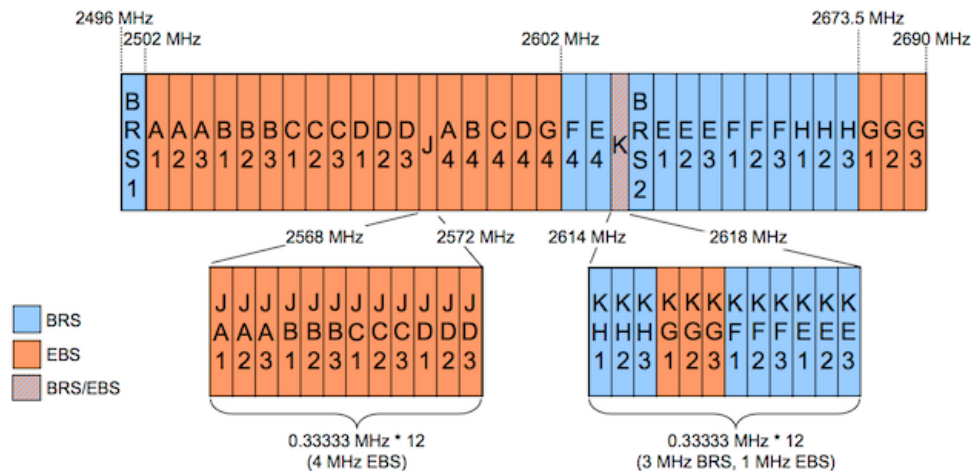
BLOCK 2: 835 – 845 MHz (B)

BLOCK 3: 845 – 846.5 MHz (A* High)

BLOCK 4: 846.5 – 849 MHz (B*)

3.4 BRS/EBS Frequency Block

§27.5



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3.5 Radiated Power and Radiated Spurious Emissions

\$2.1053 \$22.913(a)(2) \$22.917(a) \$27.53(m) \$27.50(h)(2) RSS-132(5.4) RSS-132(5.5) RSS-199(4.4) RSS-199(4.5)

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm tall test table made of Styrodur is placed on top of the turn table.

The equipment under test was transmitting while connected to its integral antenna and is placed on a turntable 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168 D01 v02r02.

Per the guidance of ANSI/TIA-603-E-2016, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_d [\text{dBm}] = P_g [\text{dBm}] - \text{cable loss} [\text{dB}] + \text{antenna gain} [\text{dBd/dBi}]$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_g [\text{dBm}] - \text{cable loss} [\text{dB}]$.

The calculated P_d levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of $43 + 10\log_{10}(\text{Power} [\text{Watts}])$. For Band 7 and 38, the calculated P_d levels are compared to the absolute spurious emission limit of -25dBm which is equivalent to the required minimum attenuation of $55 + 10\log_{10}(\text{Power} [\text{Watts}])$.

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4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of $k = 2$ to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty ($\pm$ dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx3	Licensed Transmitter Cable Set	8/10/2017	Annual	8/10/2018	LTx3
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	6/21/2017	Annual	6/21/2018	RE1
Agilent	N9020A	MXA Signal Analyzer	10/28/2016	Annual	10/28/2017	US46470561
Emco	6502	Active Loop Antenna (10k - 30 MHz)	8/9/2016	Biennial	8/9/2018	2936
Emco	3115	Horn Antenna (1-18GHz)	3/10/2016	Biennial	3/10/2018	9704-5182
Espec	ESX-2CA	Environmental Chamber	4/11/2017	Annual	4/11/2018	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	4/26/2016	Biennial	4/26/2018	125518
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	4/26/2016	Biennial	4/26/2018	128337
ETS Lindgren	3160-09	18-26.5 GHz Standard Gain Horn	8/23/2016	Biennial	8/23/2018	135427
Mini Circuits	PWR-SEN-4GHS	USB Power Sensor	3/24/2017	Annual	3/24/2018	11401010036
Mini Circuits	TVA-11-422	RF Power Amp	N/A			QA1317001
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator	N/A			11208010032
PCTEST	-	EMC Switch System	6/21/2017	Annual	6/21/2018	NM1
PCTEST	-	EMC Switch System	6/21/2017	Annual	6/21/2018	NM2
Rohde & Schwarz	FSW67	Signal / Spectrum Analyzer	8/11/2017	Annual	8/11/2018	103200
Rohde & Schwarz	CMW500	Radio Communication Tester	10/20/2016	Annual	10/20/2017	100976
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	7/31/2017	Annual	7/31/2018	100348
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	5/11/2017	Annual	5/11/2018	100040
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	11/18/2015	Biennial	11/18/2017	91052523RX
Seekonk	NC-100	Torque Wrench 5/16", 8" lbs	3/2/2016	Biennial	3/2/2018	N/A
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	3/14/2016	Biennial	3/14/2018	A051107

Table 5-1. Test Equipment

Notes:

- For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
- Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was –81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of –81.0 dBm on the spectrum analyzer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of –30.9 dBm yielding –24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

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7.0 TEST RESULTS

7.1 Summary

Company Name: Samsung Electronics Co., Ltd.
 FCC ID: A3LSMJ250F
 FCC Classification: TNE (Licensed Non-Broadcast Transmitter Held to Ear)
 Mode(s): LTE

FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
2.1049	RSS-Gen(4.6.1)	Occupied Bandwidth	N/A	CONDUCTED	PASS	Section 7.2
2.1051 2.917(a)	RSS-132(5.5)	Out of Band Emissions (Band 5)	$> 43 + 10\log_{10}(P[\text{Watts}])$ at Band Edge and for all out-of-band emissions		PASS	Section 7.3, 7.4
27.53(m)	RSS-199(4.5)	Out of Band Emissions (Band 7, 38)	Undesirable emissions must meet the limits detailed in 27.53(m) (RSS-199 [6.4])		PASS	Section 7.3, 7.4
2.1046	RSS-132(5.4) RSS-199(4.4)	Transmitter Conducted Output Power	N/A		PASS	See RF Exposure Report
2.1055 22.355 27.54	RSS-132(5.3) RSS-199(4.3)	Frequency Stability (Band 5, 7, 38)	< 2.5 ppm (Part 22) and fundamental emissions stay within authorized frequency block (Part 27)		PASS	Section 7.7

Table 7-1. Summary of Conducted Test Results

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FCC Part Section(s)	RSS Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
22.913(a)(2)	RSS-132(5.4)	Effective Radiated Power / Equivalent Isotropic Radiated Power (Band 5)	< 7 Watts max. ERP < 11.5 Watts max. EIRP	RADIATED	PASS	Section 7.5
27.50(h)(2)	RSS-199(4.4)	Equivalent Isotropic Radiated Power (Band 7,38)	< 2 Watts max. EIRP		PASS	Section 7.5
2.1053 22.917(a)	RSS-132(5.5)	Undesirable Emissions (Band 5)	> 43 + 10log ₁₀ (P[Watts]) for all out-of-band emissions		PASS	Section 7.6
27.53(m)	RSS-199(4.5)	Undesirable Emissions (Band 7, 38)	Undesirable emissions must meet the limits detailed in 27.53(m) (RSS-199 [6.4])		PASS	Section 7.6

Table 7-2. Summary of Radiated Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots (Sections 7.2, 7.3, and 7.4) were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "LTE Automation," Version 4.8.

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7.2 Occupied Bandwidth

§2.1049 RSS-Gen (4.6.1)

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 4.2

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5% of the expected OBW
3. VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

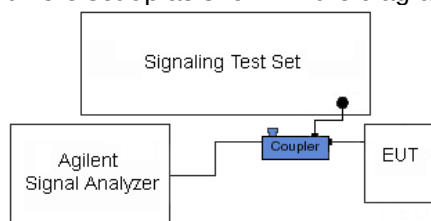
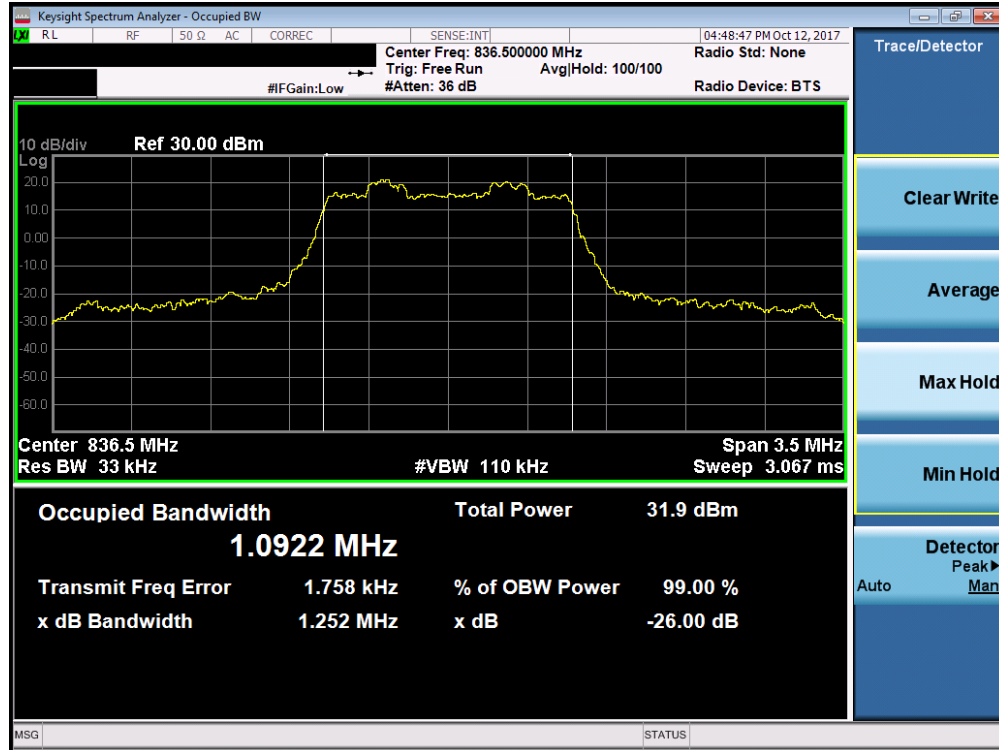


Figure 7-1. Test Instrument & Measurement Setup

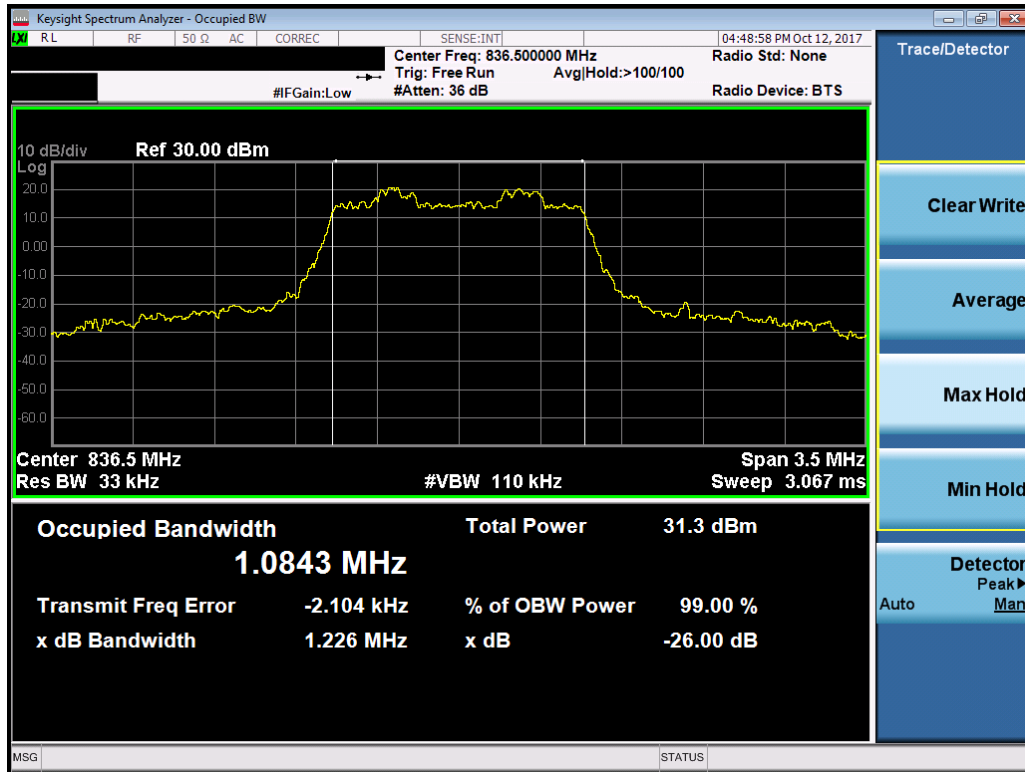
Test Notes

None.

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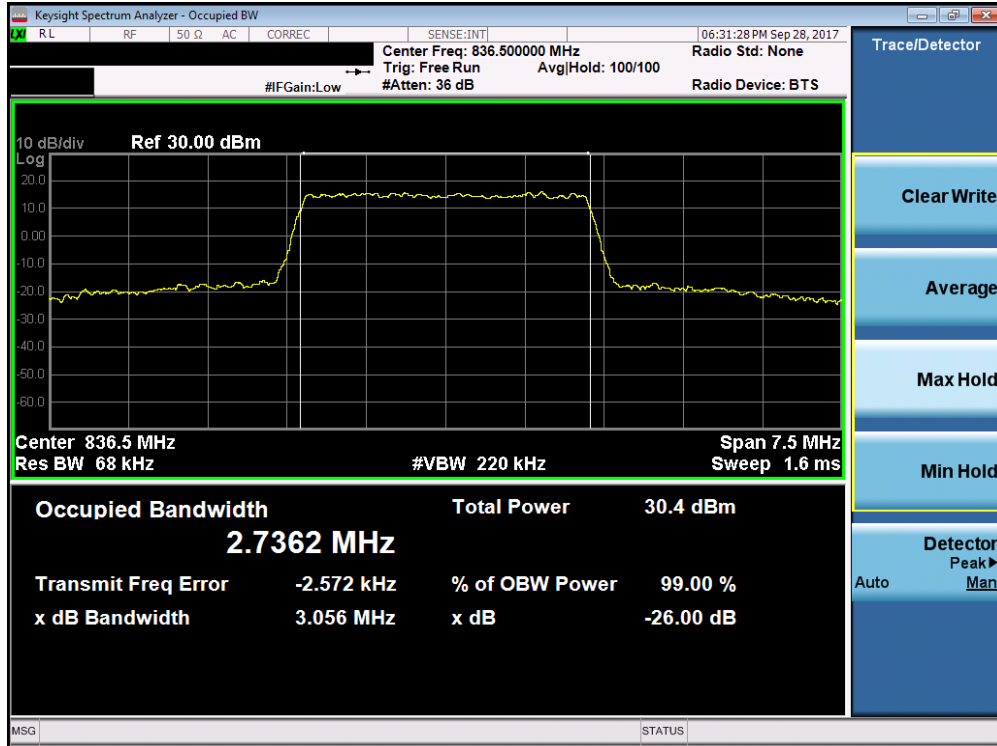


Plot 7-3. Occupied Bandwidth Plot (Band 5 - 1.4MHz QPSK - RB Size 6)

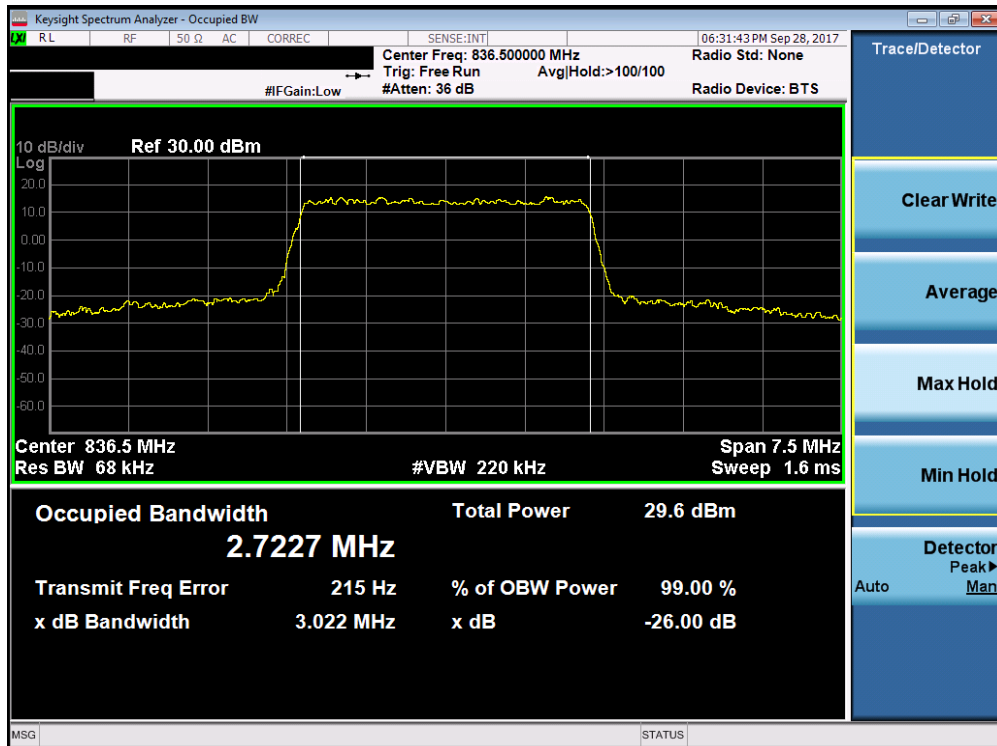


Plot 7-4. Occupied Bandwidth Plot (Band 5 - 1.4MHz 16-QAM - RB Size 6)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 14 of 74

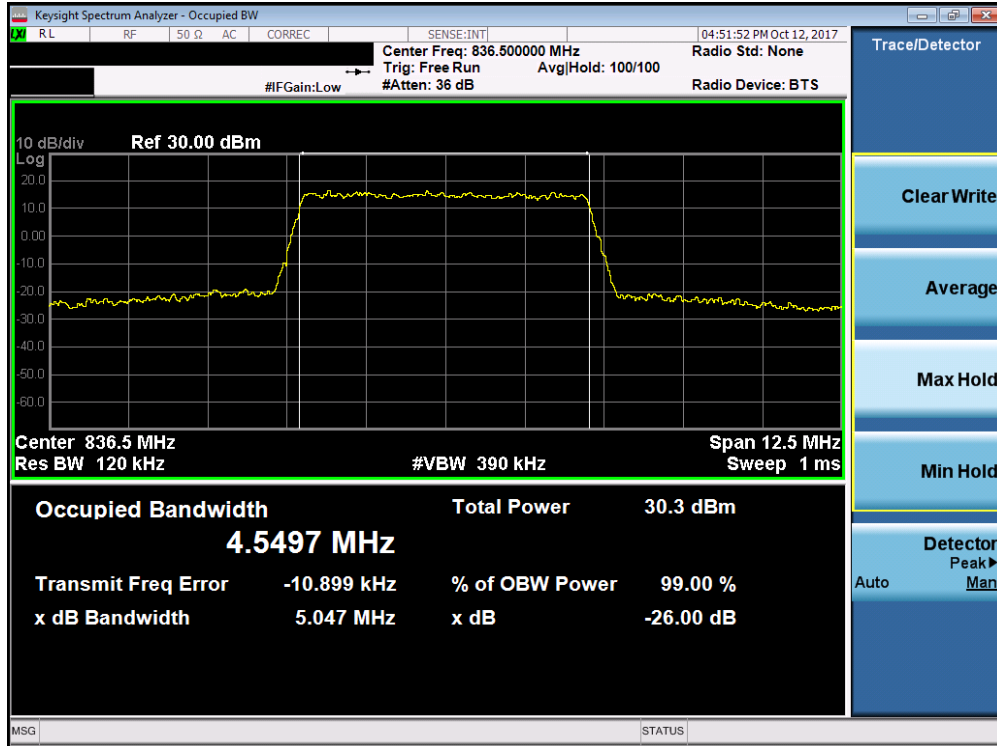


Plot 7-5. Occupied Bandwidth Plot (Band 5 - 3.0MHz QPSK - RB Size 15)

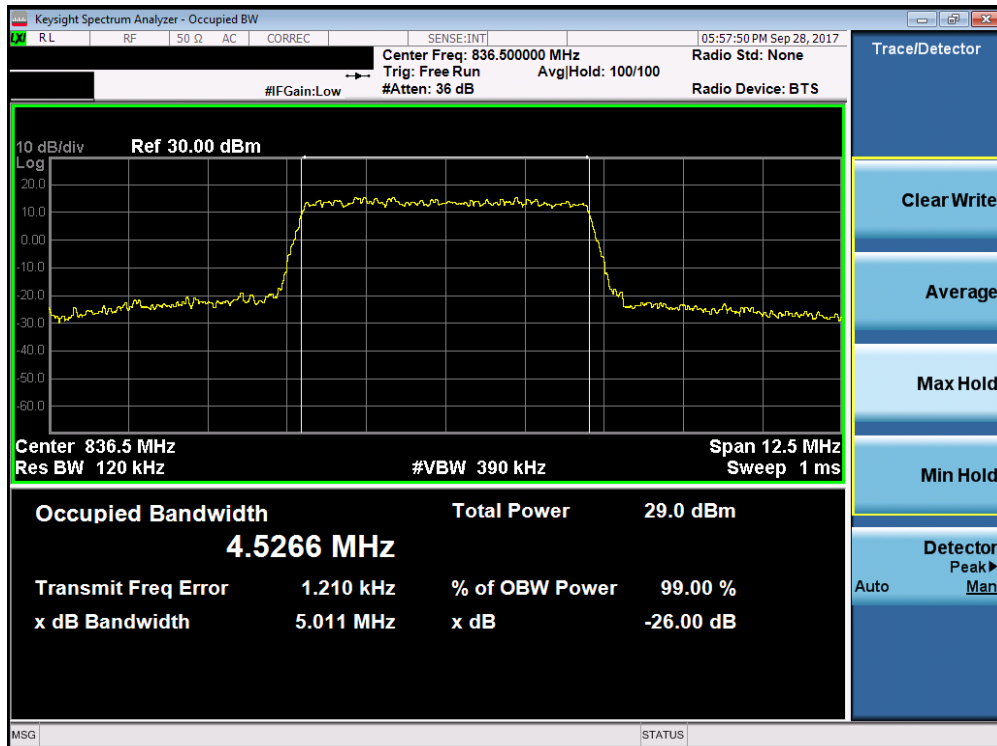


Plot 7-6. Occupied Bandwidth Plot (Band 5 - 3.0MHz 16-QAM - RB Size 15)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 15 of 74

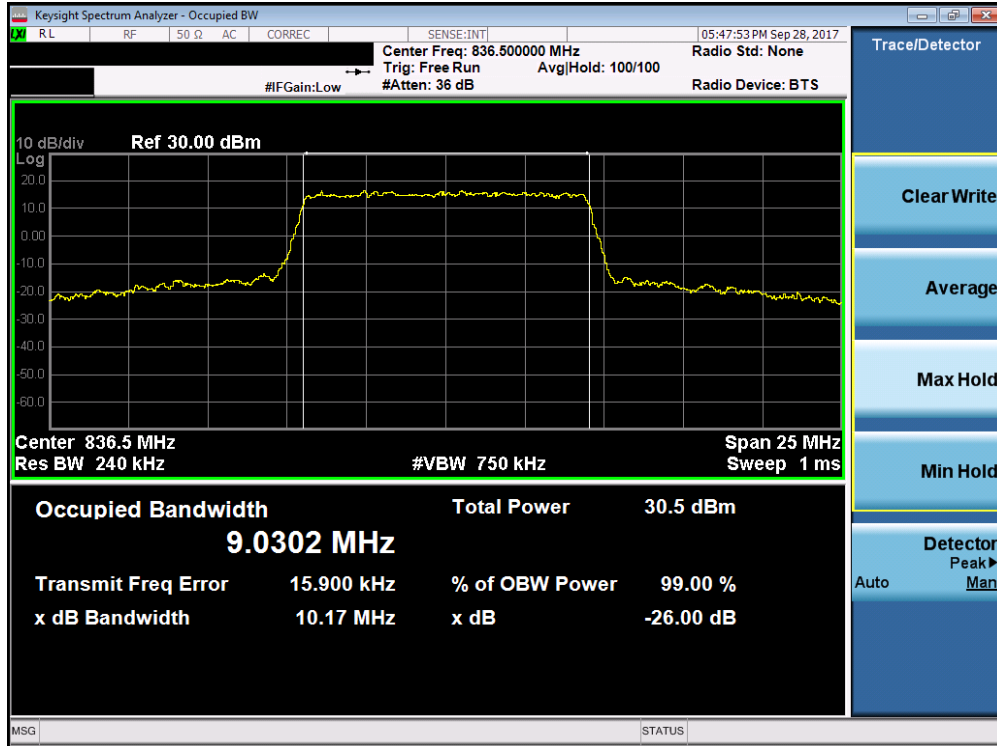


Plot 7-7. Occupied Bandwidth Plot (Band 5 - 5.0MHz QPSK - RB Size 25)

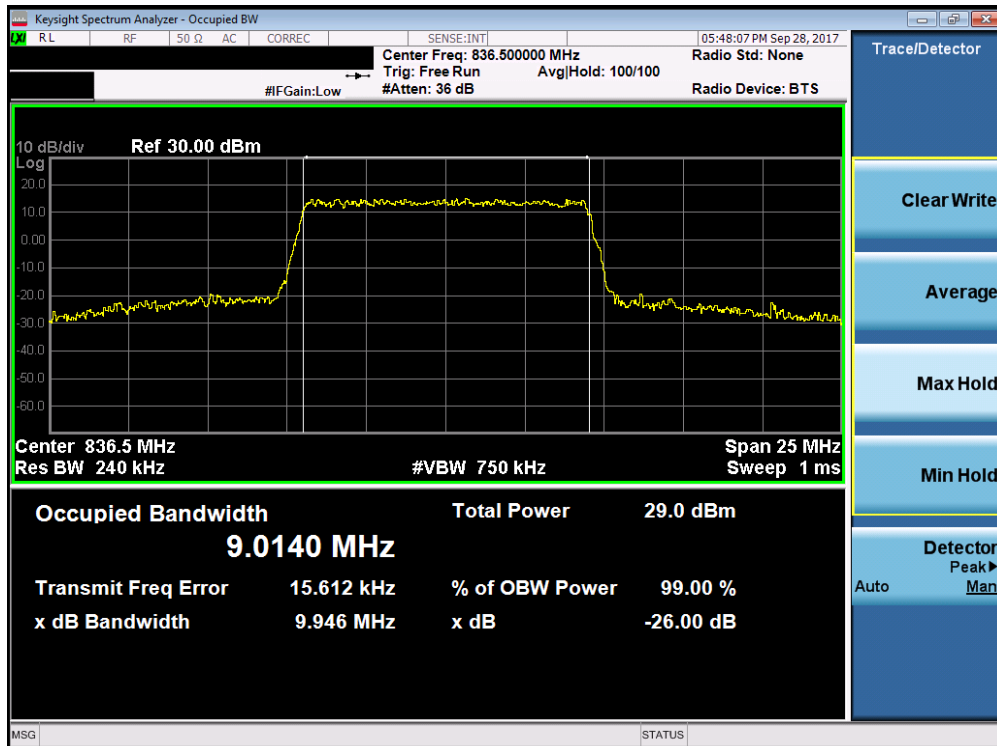


Plot 7-8. Occupied Bandwidth Plot (Band 5 - 5.0MHz 16-QAM - RB Size 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 16 of 74

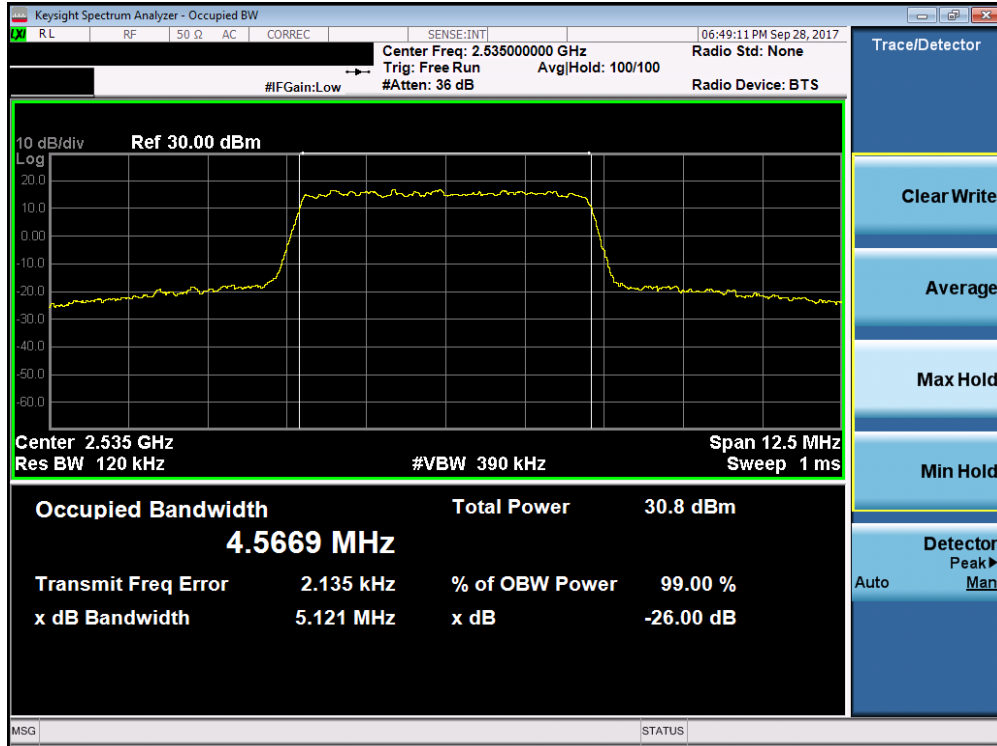


Plot 7-9. Occupied Bandwidth Plot (Band 5 - 10.0MHz QPSK - RB Size 50)

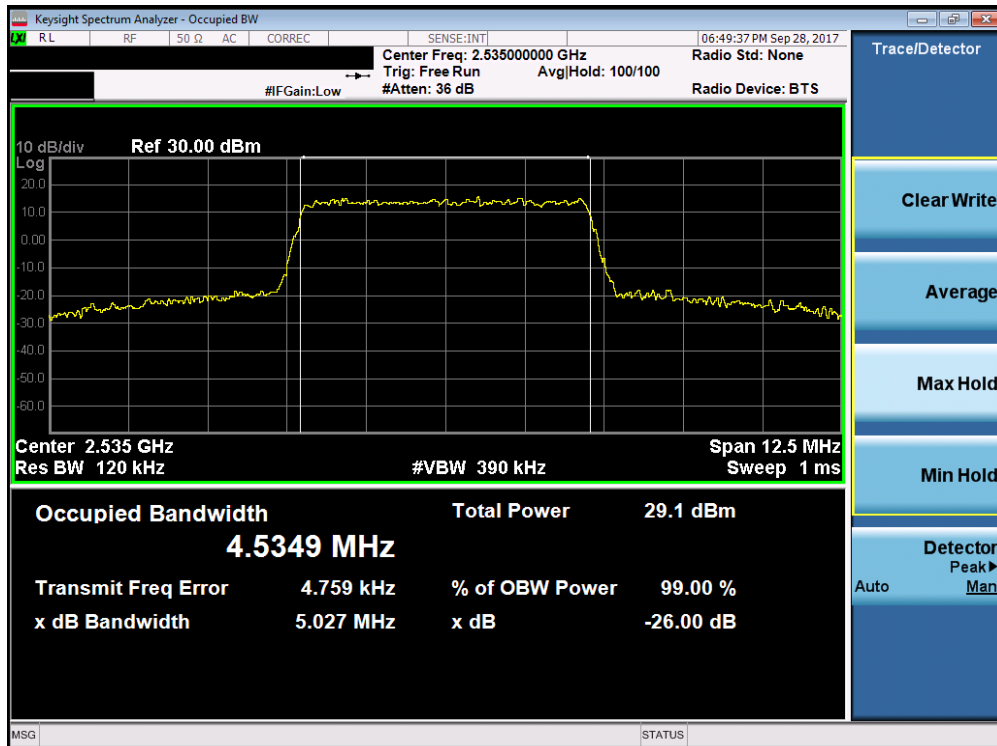


Plot 7-10. Occupied Bandwidth Plot (Band 5 - 10.0MHz 16-QAM - RB Size 50)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 17 of 74

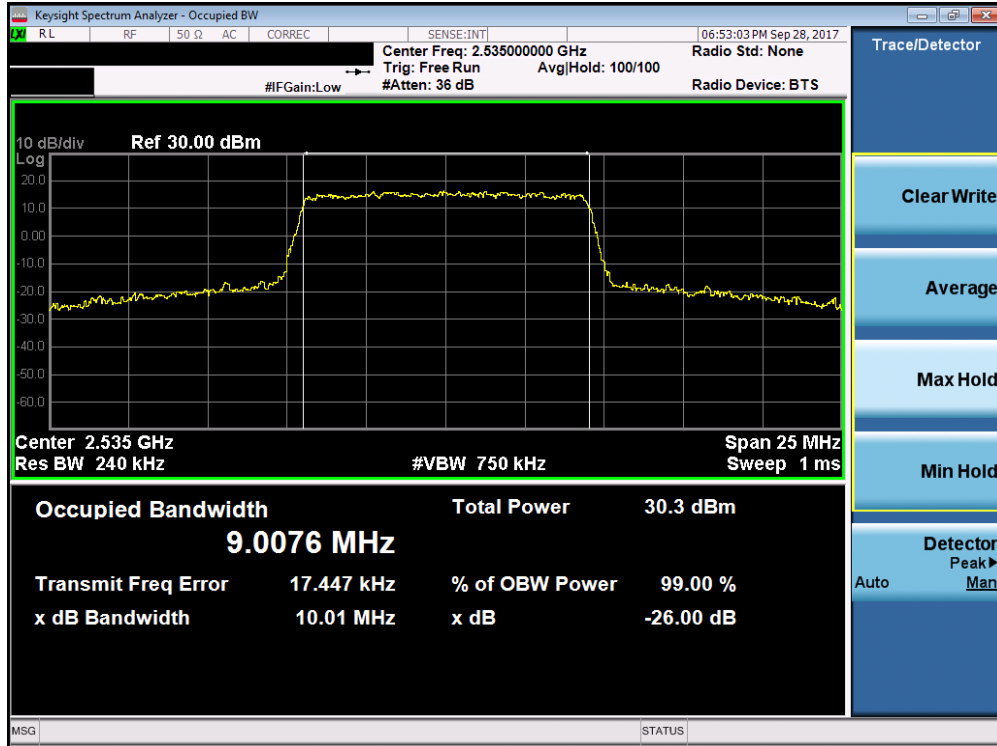


Plot 7-11. Occupied Bandwidth Plot (Band 7 - 5.0MHz QPSK - RB Size 25)

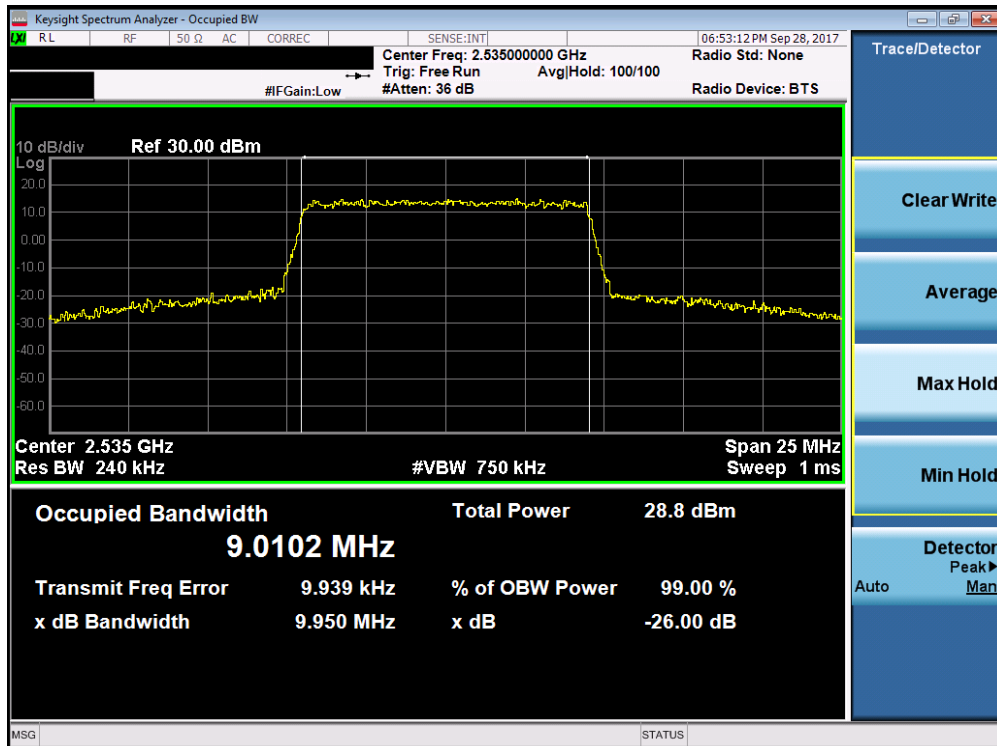


Plot 7-12. Occupied Bandwidth Plot (Band 7 - 5.0MHz 16-QAM - RB Size 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03-A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 18 of 74

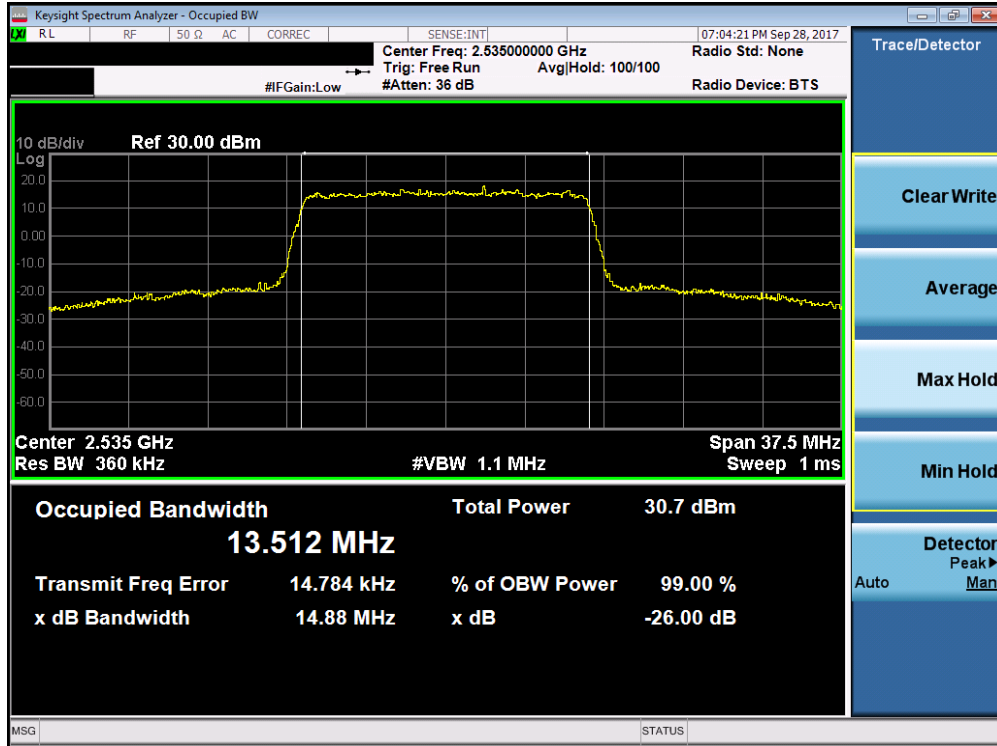


Plot 7-13. Occupied Bandwidth Plot (Band 7 - 10.0MHz QPSK - RB Size 50)

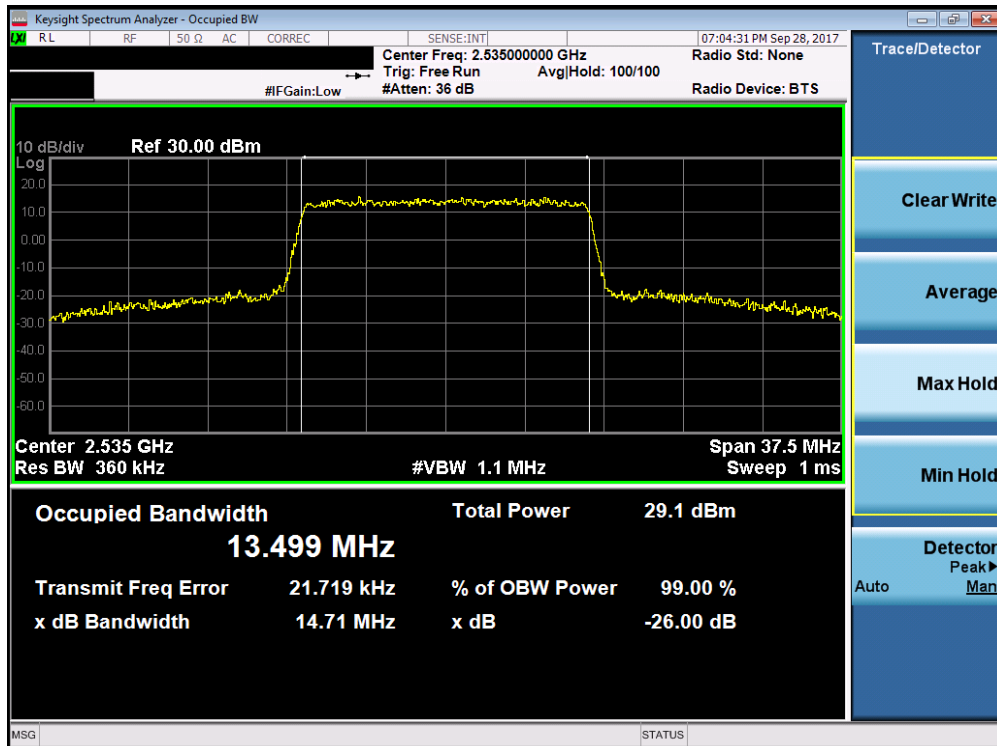


Plot 7-14. Occupied Bandwidth Plot (Band 7 - 10.0MHz 16-QAM - RB Size 50)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 19 of 74

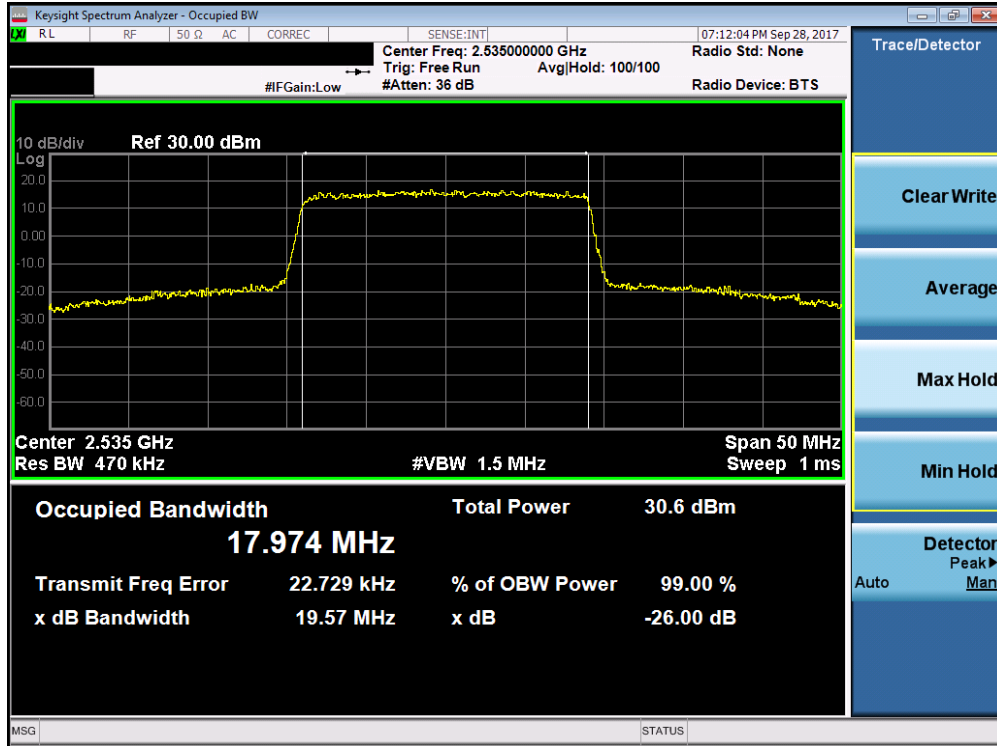


Plot 7-15. Occupied Bandwidth Plot (Band 7 - 15.0MHz QPSK - RB Size 75)

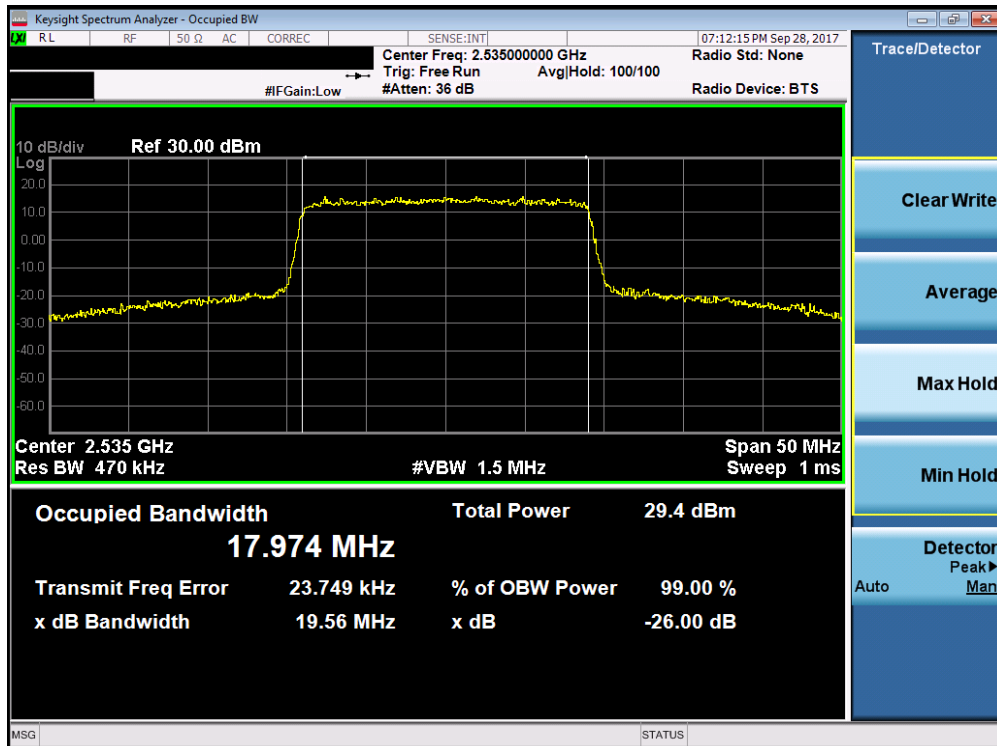


Plot 7-16. Occupied Bandwidth Plot (Band 7 - 15.0MHz 16-QAM - RB Size 75)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 20 of 74

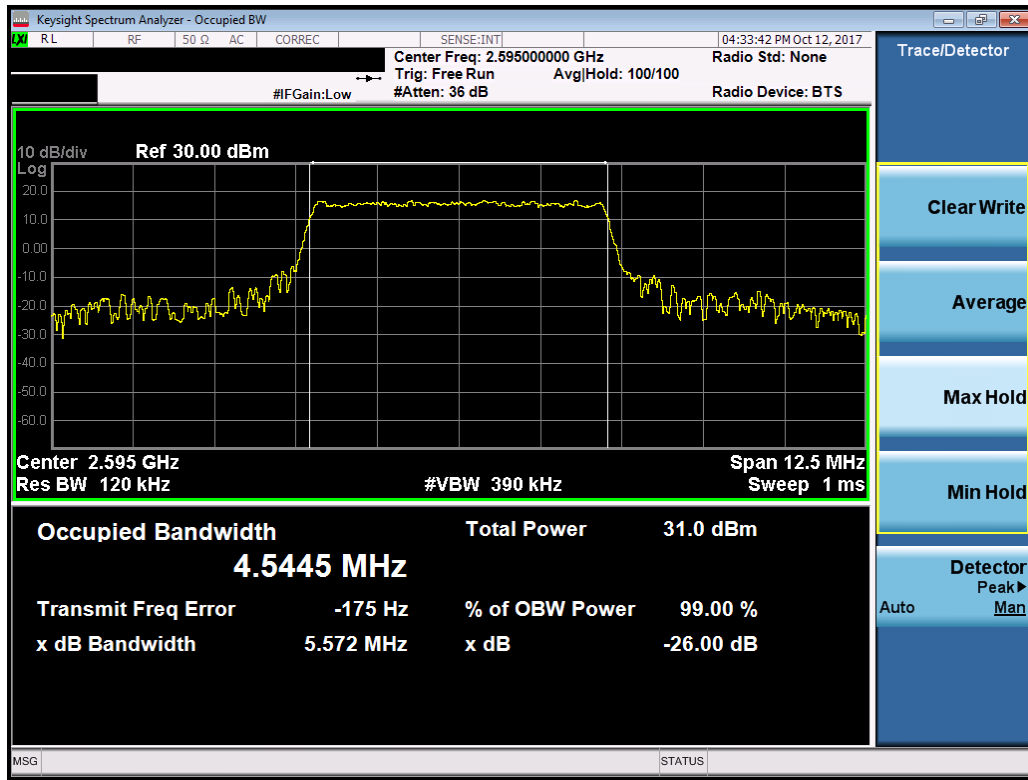


Plot 7-17. Occupied Bandwidth Plot (Band 7 - 20.0MHz QPSK - RB Size 100)

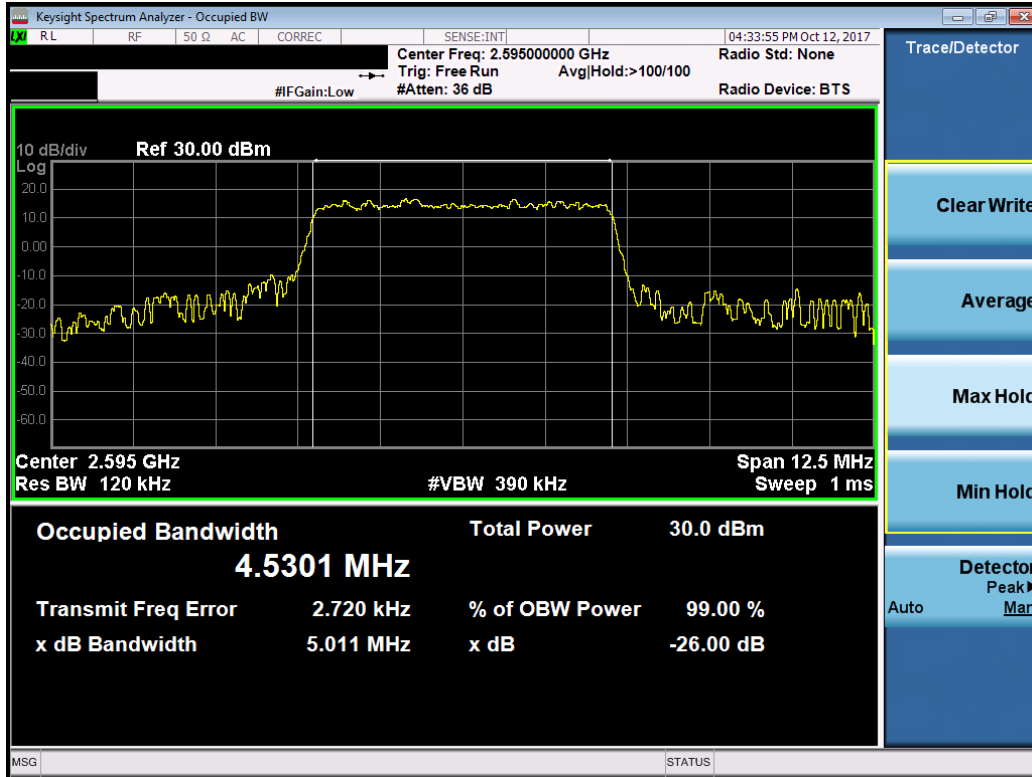


Plot 7-18. Occupied Bandwidth Plot (Band 7 - 20.0MHz 16-QAM - RB Size 100)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 21 of 74

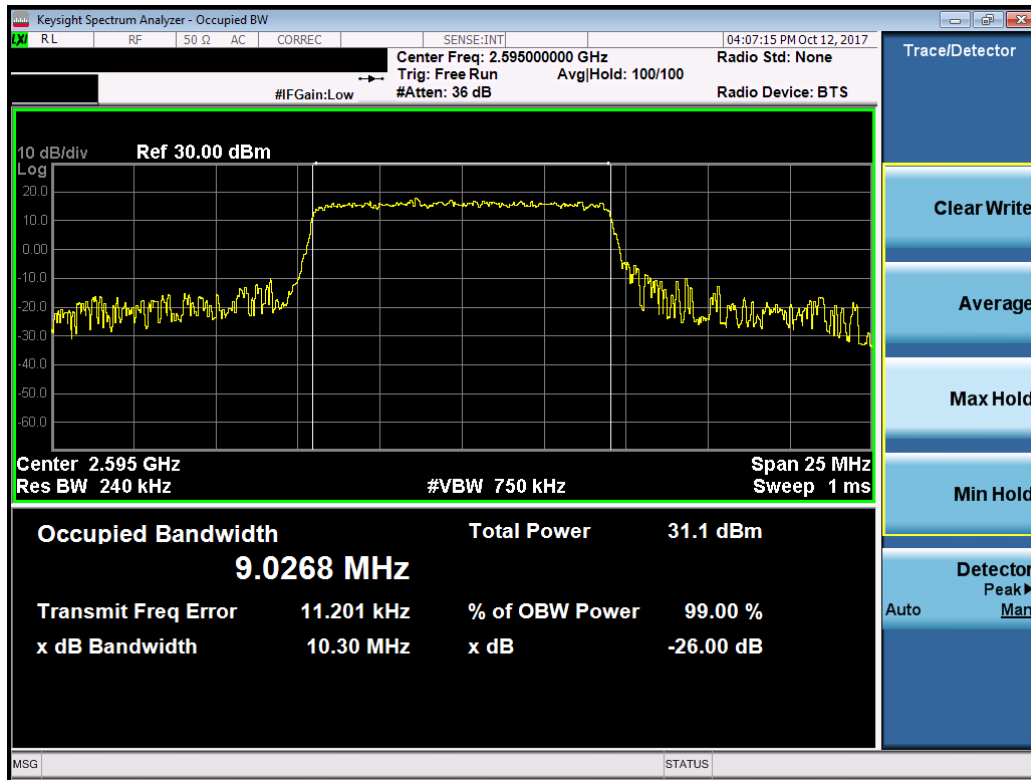


Plot 7-1. Occupied Bandwidth Plot (Band 38 – 5.0MHz QPSK – RB Size 25)

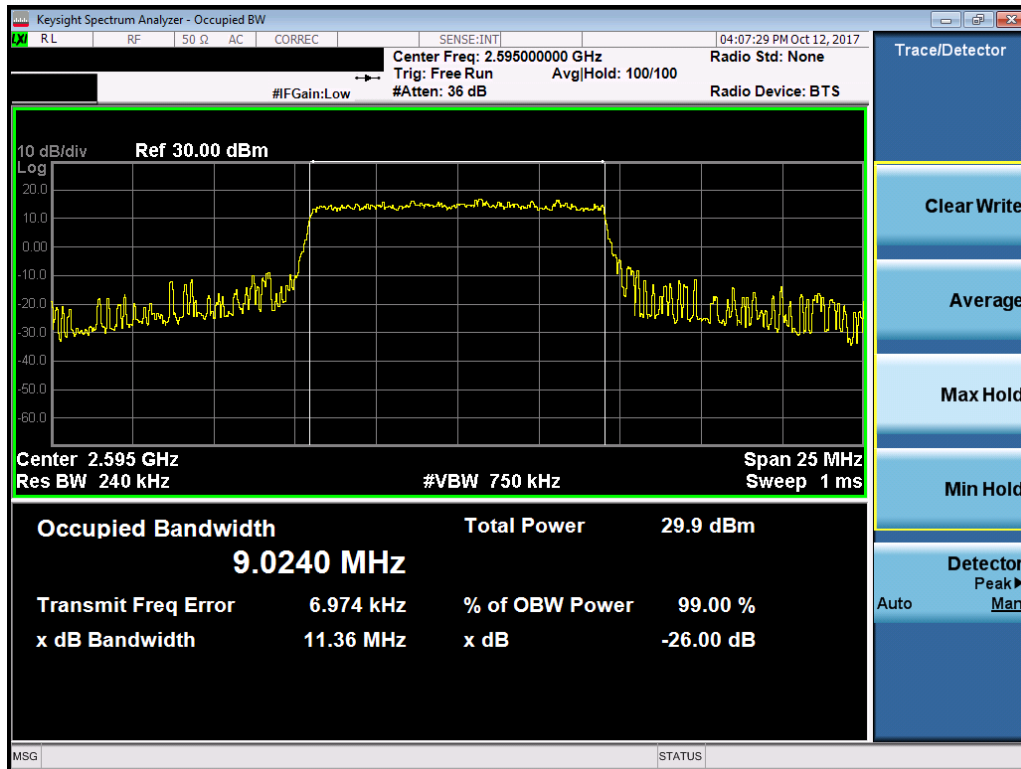


Plot 7-2. Occupied Bandwidth Plot (Band 38 – 5.0MHz 16-QAM – RB Size 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 22 of 74

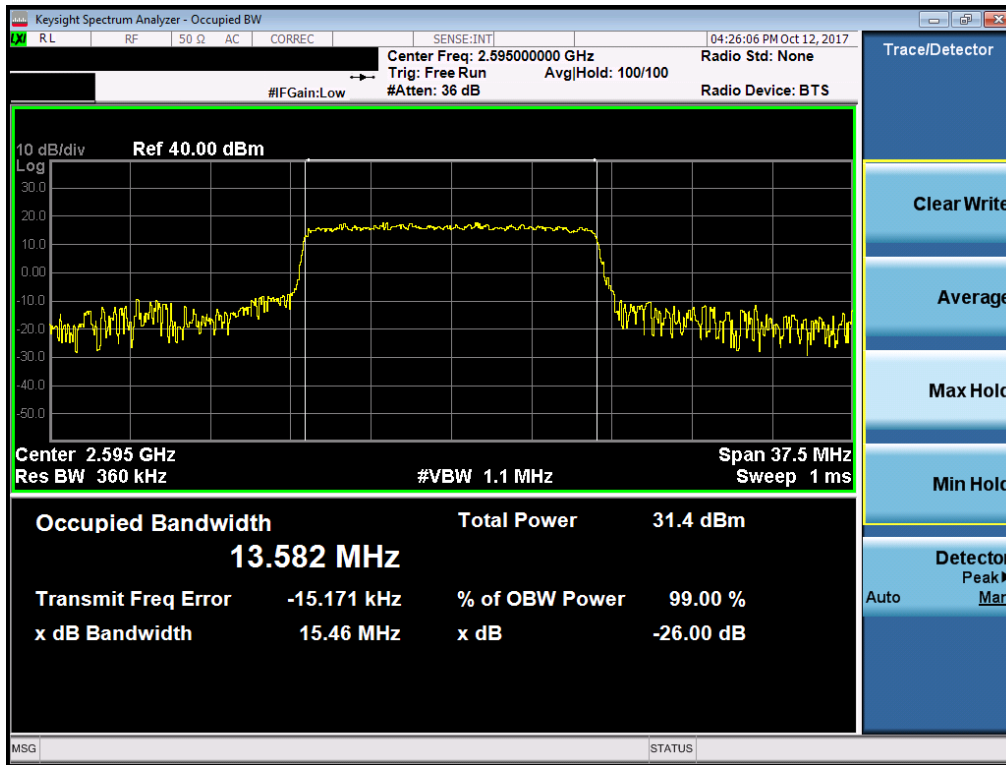


Plot 7-3. Occupied Bandwidth Plot (Band 38 – 10.0MHz QPSK – RB Size 50)

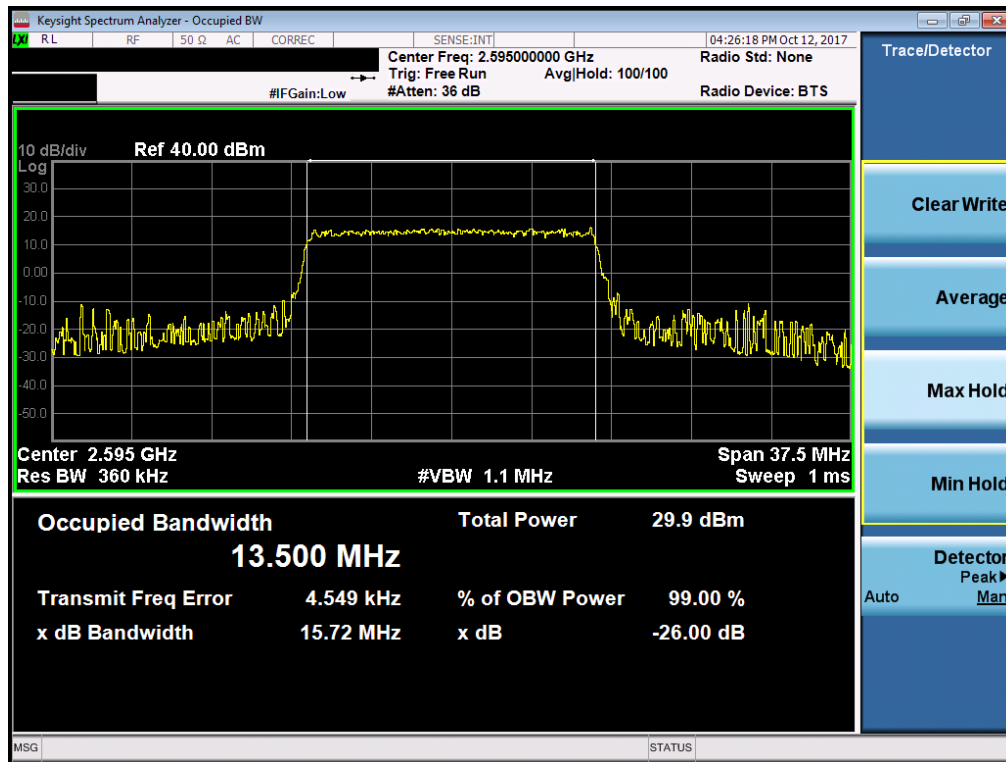


Plot 7-4. Occupied Bandwidth Plot (Band 38 – 10.0MHz 16-QAM – RB Size 50)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 23 of 74

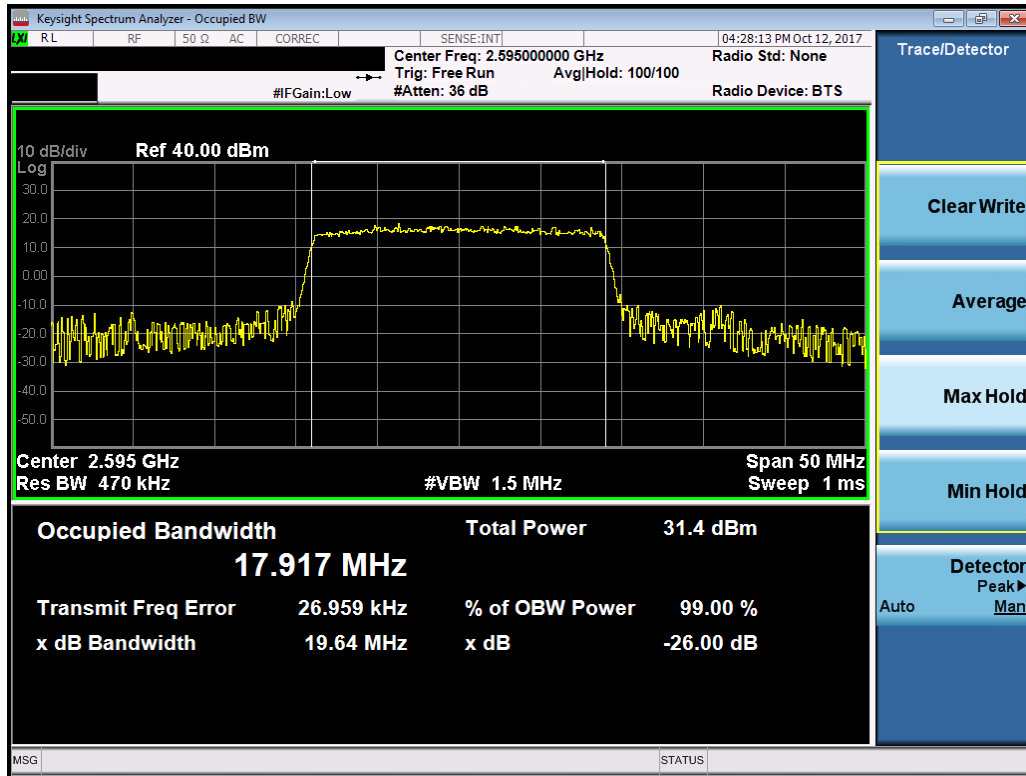


Plot 7-5. Occupied Bandwidth Plot (Band 38 – 15.0MHz QPSK – RB Size 75)

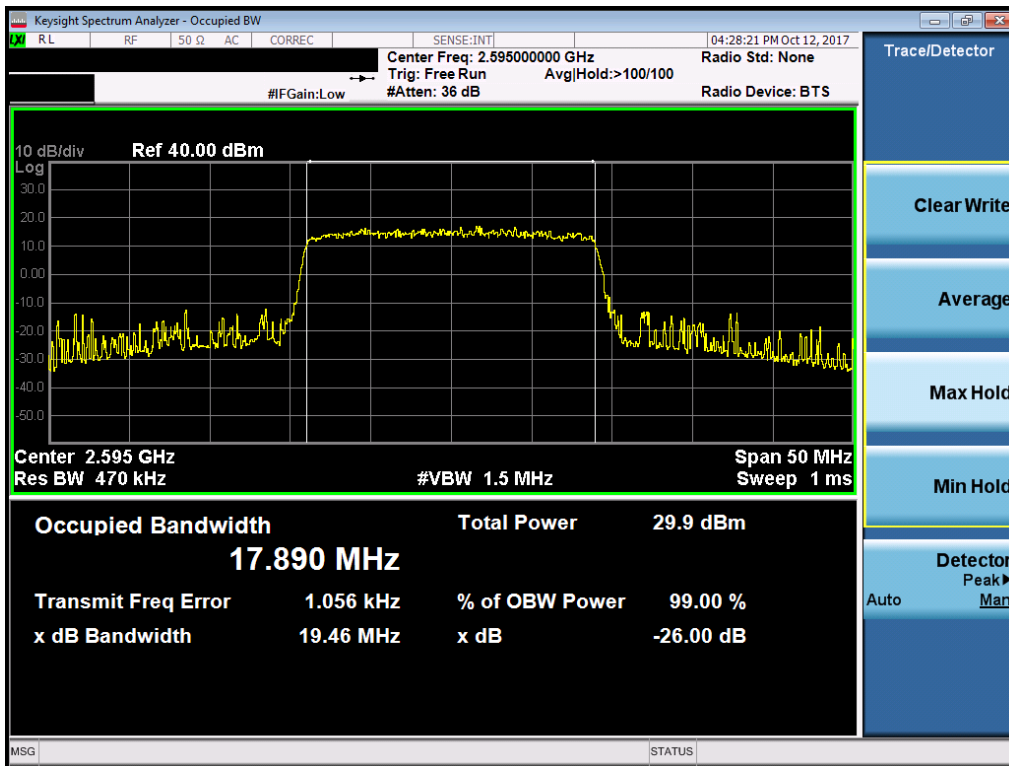


Plot 7-6. Occupied Bandwidth Plot (Band 38 – 15.0MHz 16-QAM – RB Size 75)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 24 of 74



Plot 7-7. Occupied Bandwidth Plot (Band 38 – 20.0MHz QPSK – RB Size 100)



Plot 7-8. Occupied Bandwidth Plot (Band 38 – 20.0MHz 16-QAM – RB Size 100)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 25 of 74

7.3 Spurious and Harmonic Emissions at Antenna Terminal

§2.1051 §22.917(a) §27.53(m) RSS-132(5.5) RSS-199(4.5)

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{\text{Watts}})$, where P is the transmitter power in Watts.

For Band 7 and 38, the minimum permissible attenuation level of any spurious emission is $55 + \log_{10}(P_{\text{Watts}})$.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 6.0

Test Settings

1. Start frequency was set to 30MHz and stop frequency was set to at least 10 * the fundamental frequency (separated into at least two plots per channel)
2. Detector = RMS
3. Trace mode = trace average for continuous emissions, max hold for pulse emissions
4. Sweep time = auto couple
5. The trace was allowed to stabilize
6. Please see test notes below for RBW and VBW settings

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

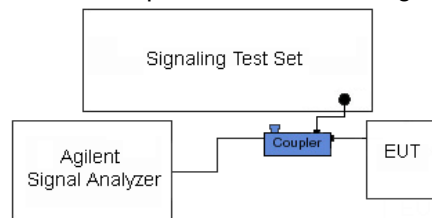


Figure 7-2. Test Instrument & Measurement Setup

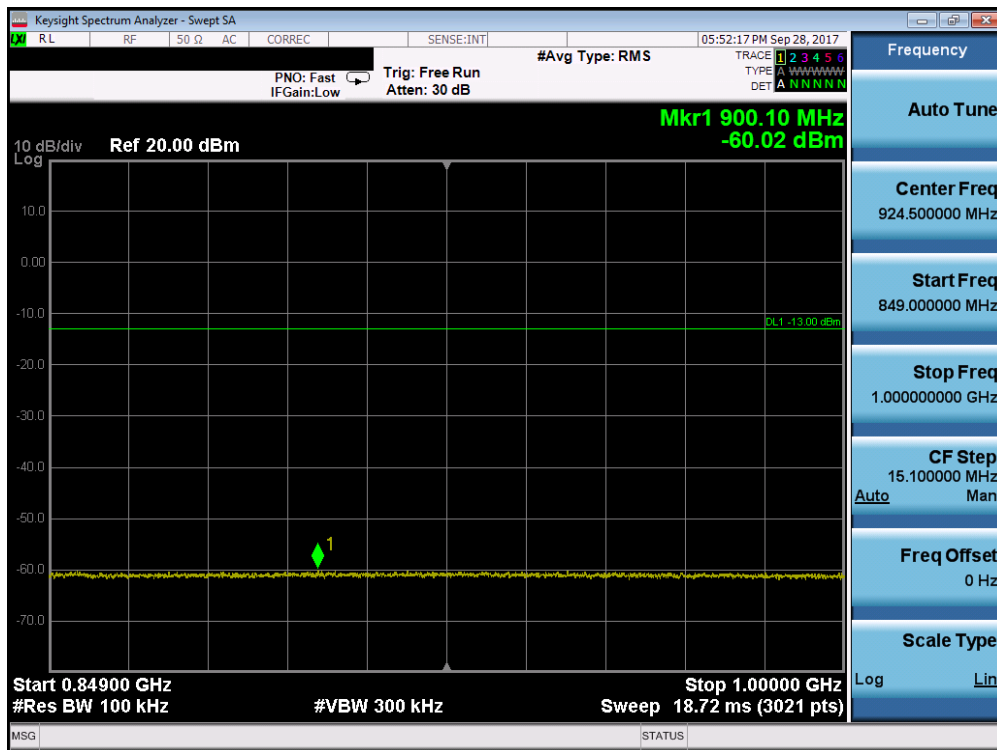
Test Notes

Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for frequencies less than 1 GHz and 1 MHz or greater for frequencies greater than 1 GHz. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 26 of 74

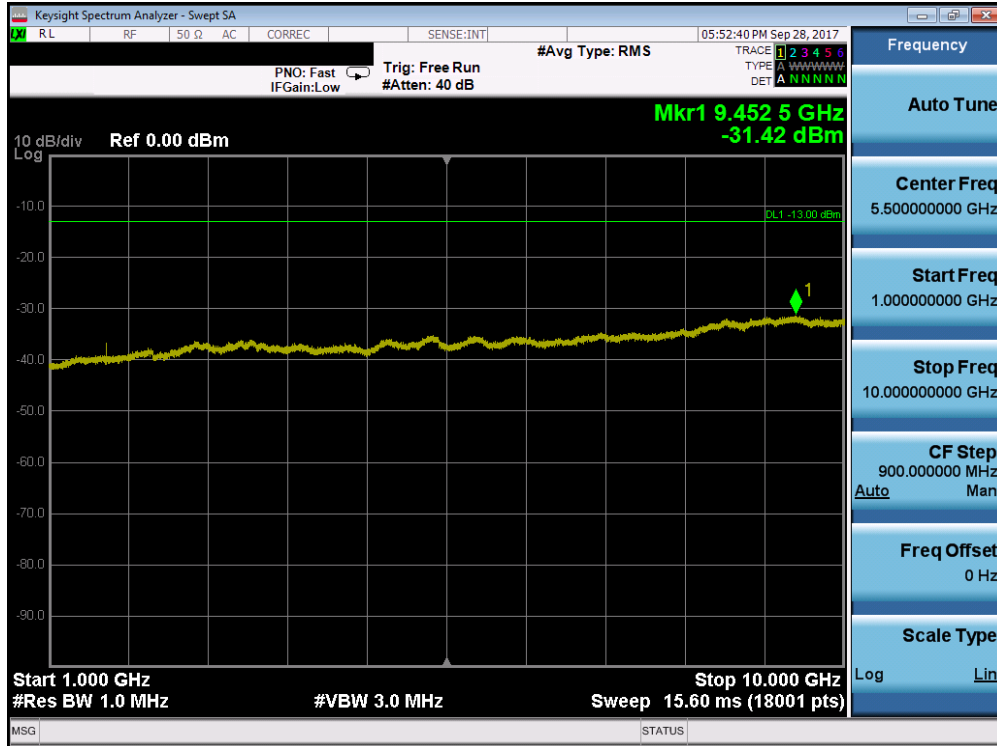


Plot 7-9. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

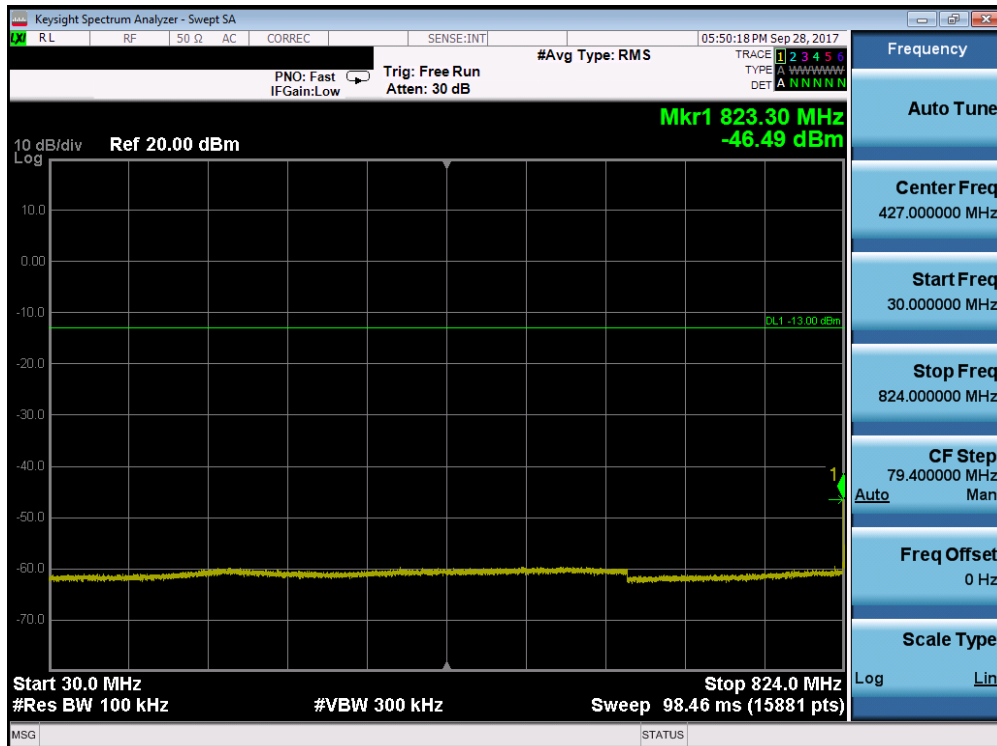


Plot 7-10. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 27 of 74

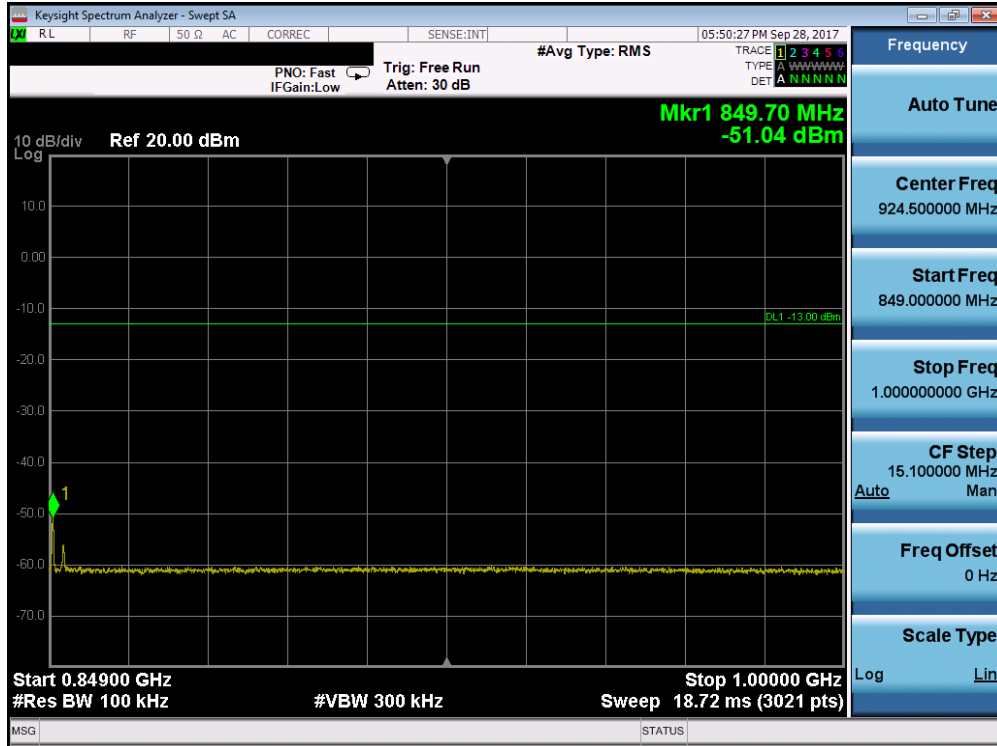


Plot 7-11. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

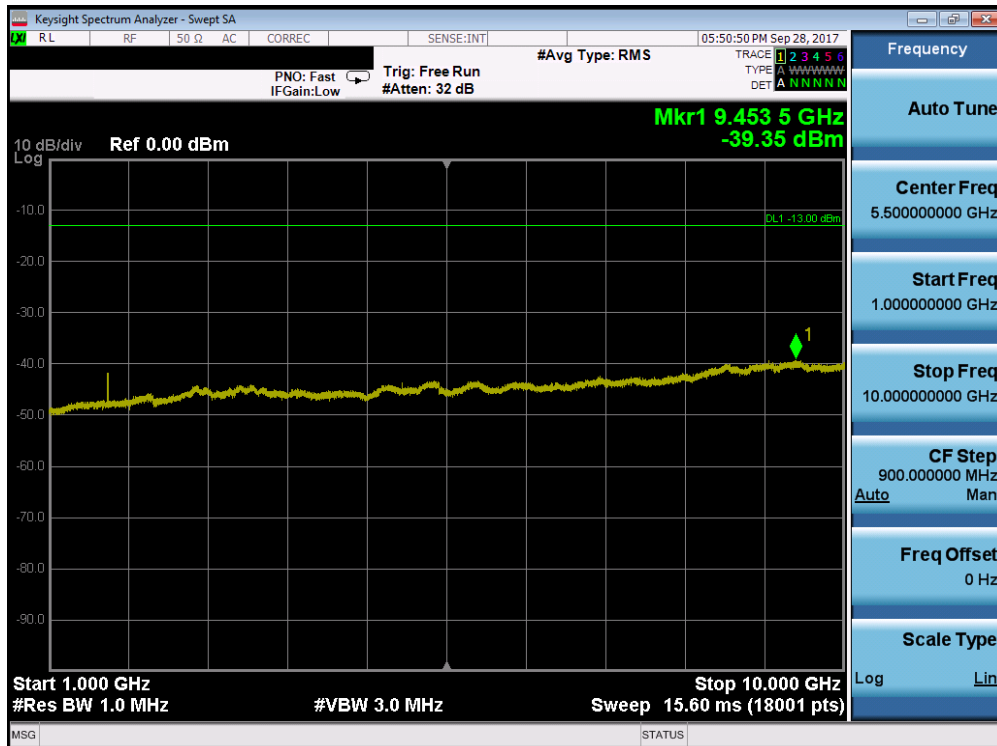


Plot 7-12. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 28 of 74

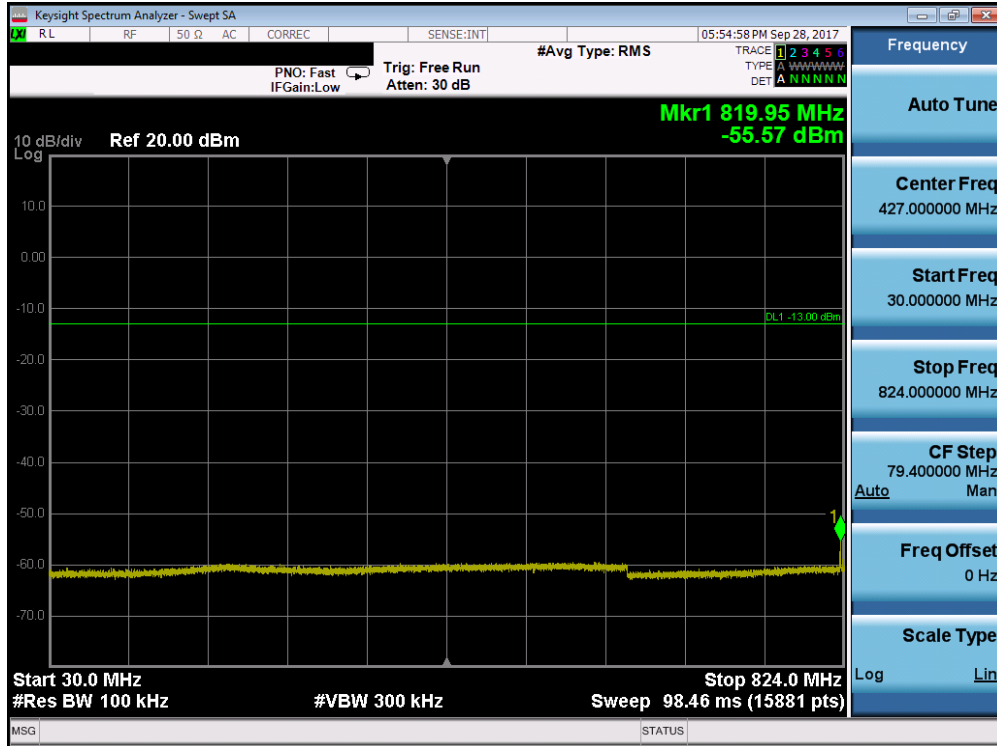


Plot 7-13. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

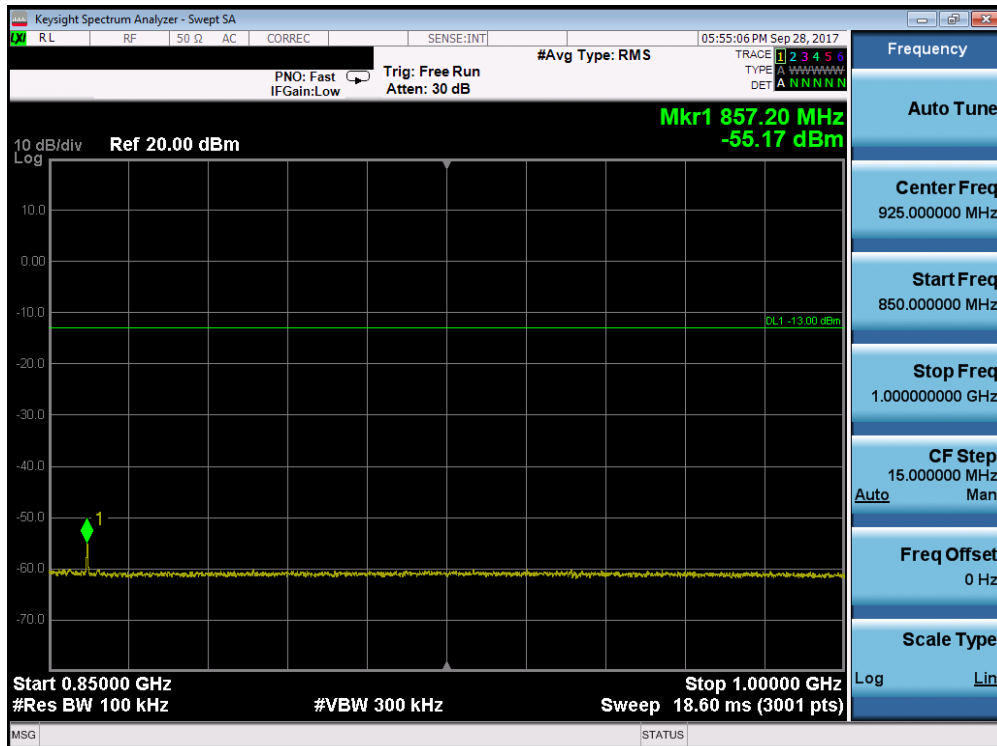


Plot 7-14. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 29 of 74

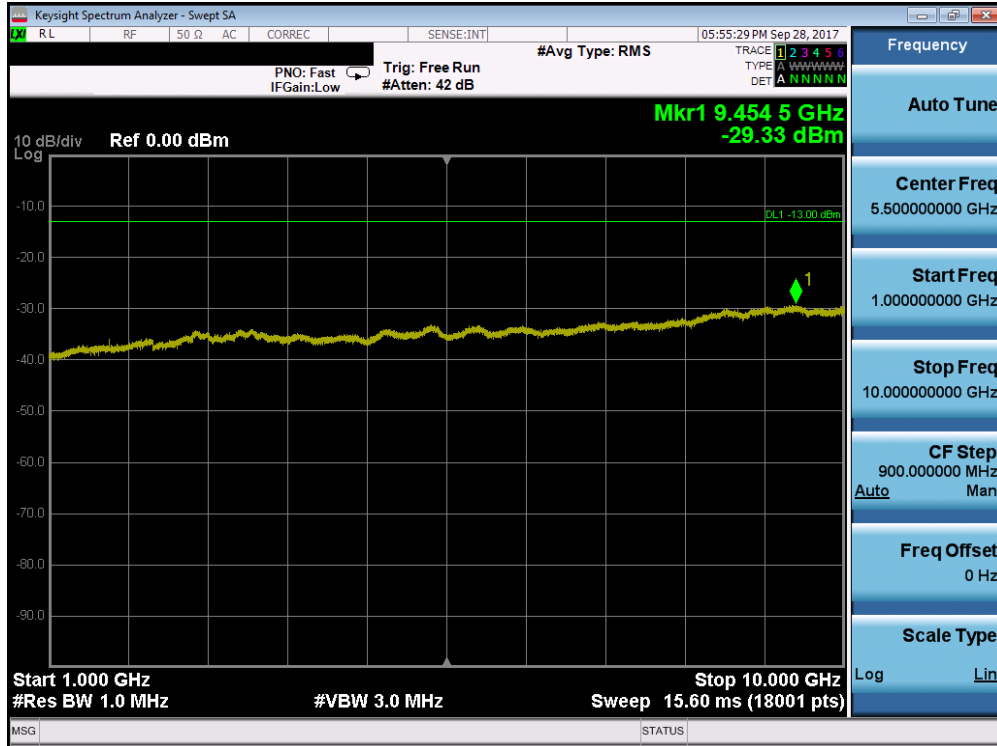


Plot 7-15. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-16. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 30 of 74

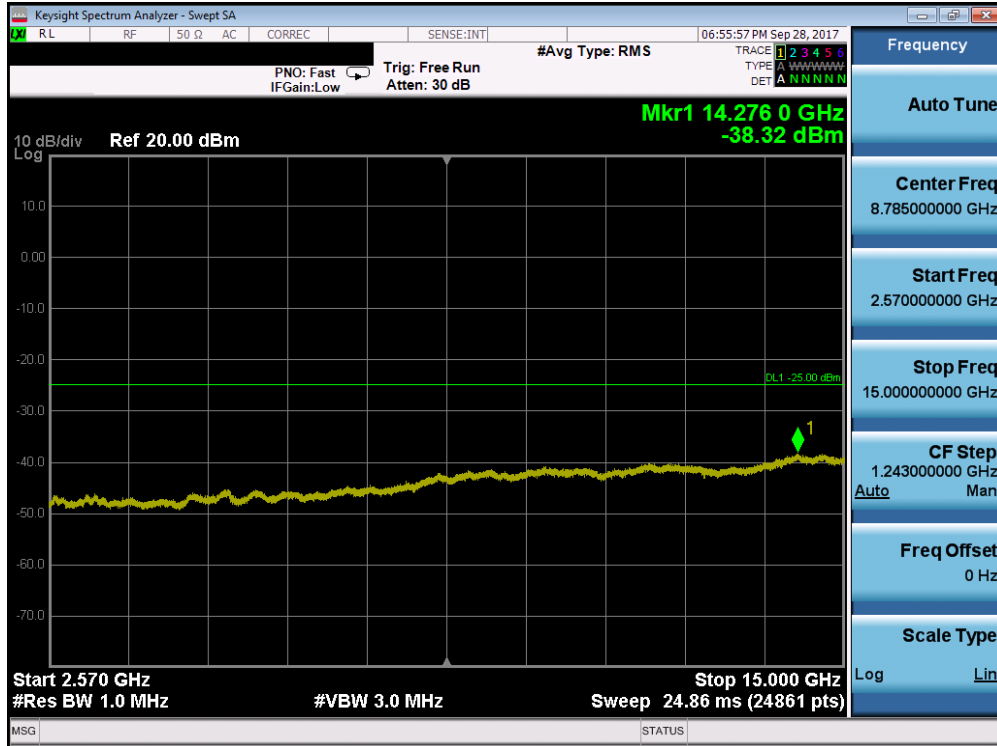


Plot 7-17. Conducted Spurious Plot (Band 5 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

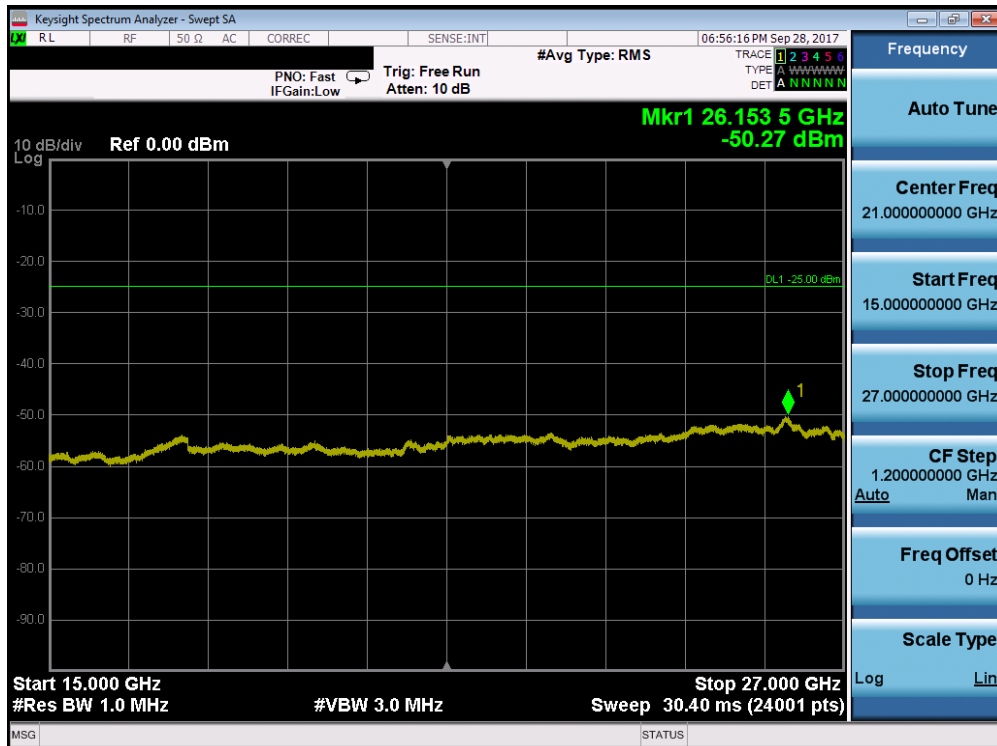


Plot 7-18. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 31 of 74

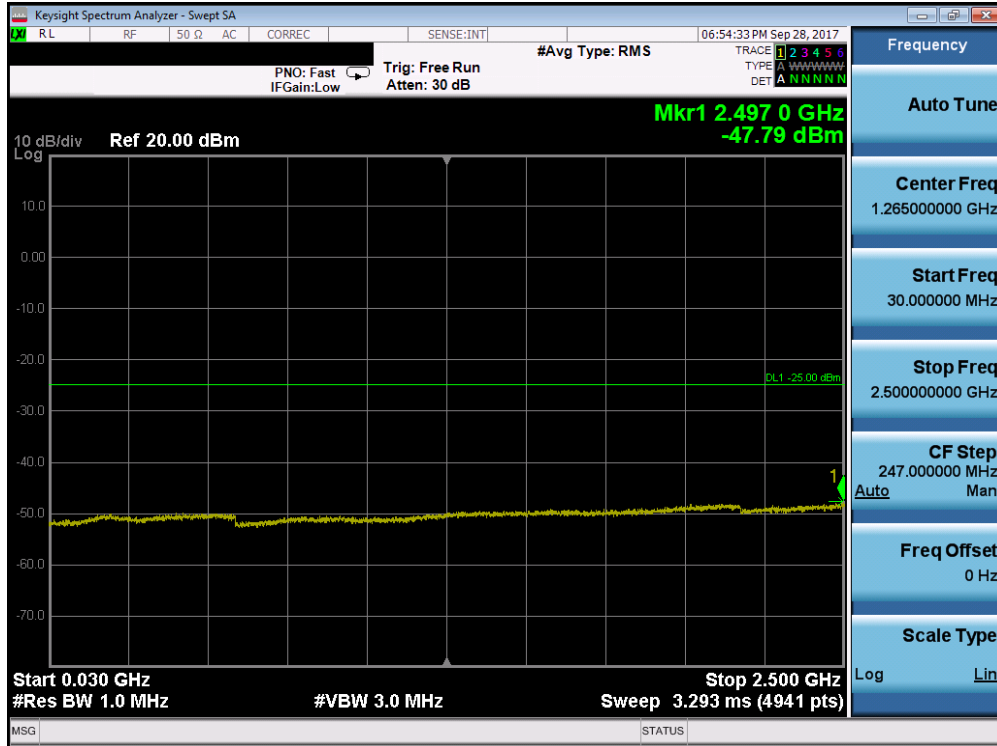


Plot 7-19. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



Plot 7-20. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 32 of 74

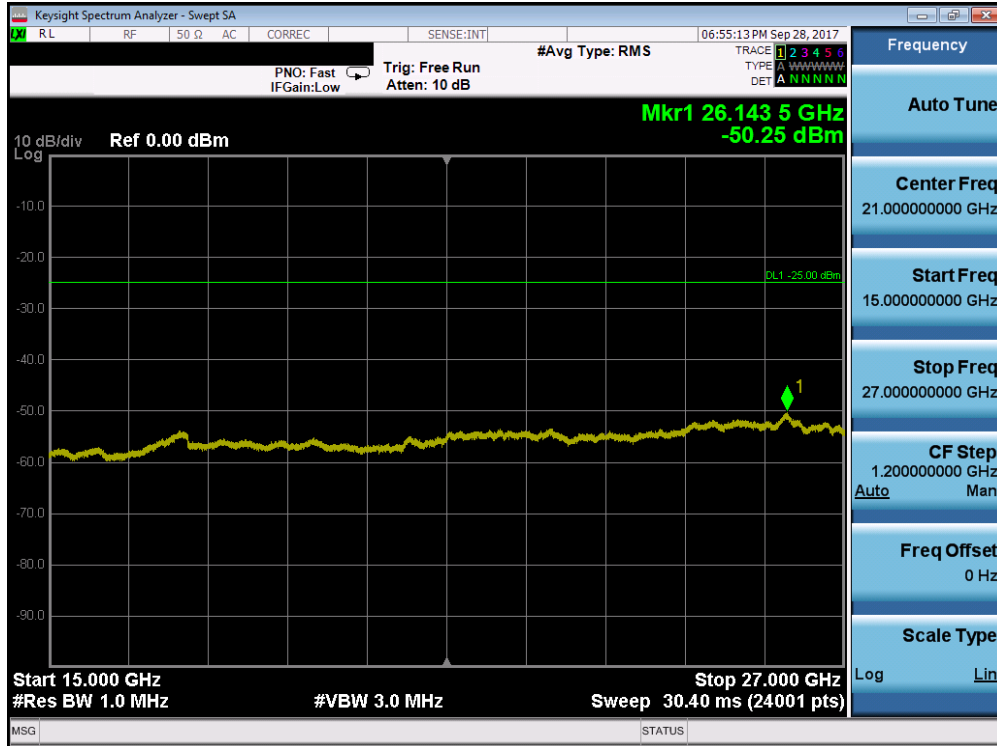


Plot 7-21. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)



Plot 7-22. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 33 of 74

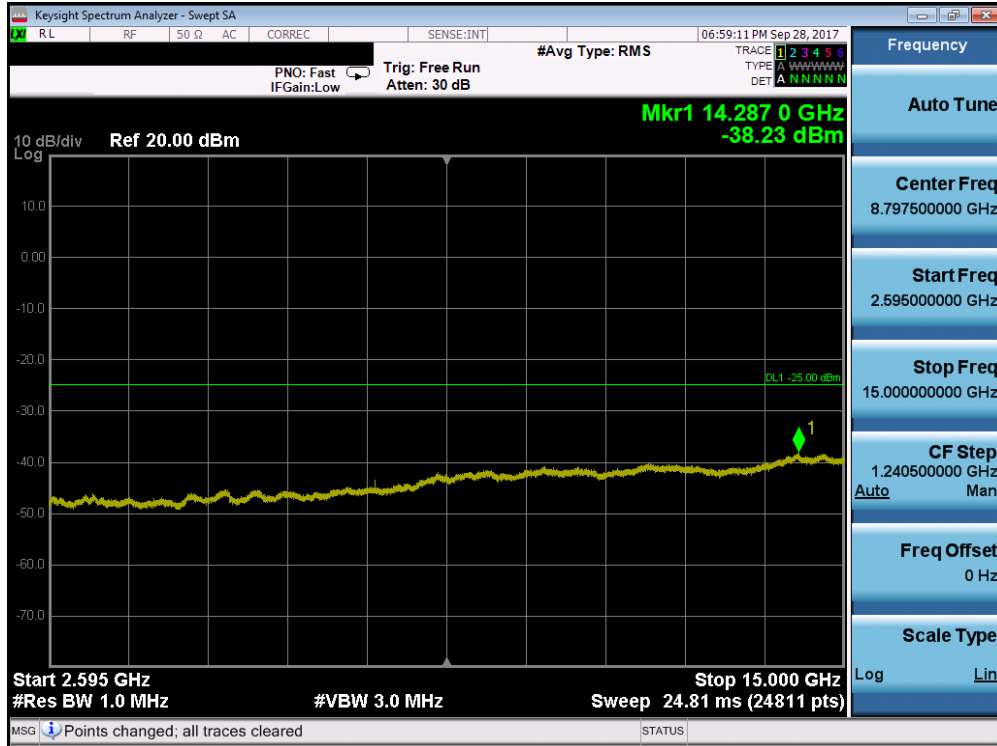


Plot 7-23. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - Mid Channel)

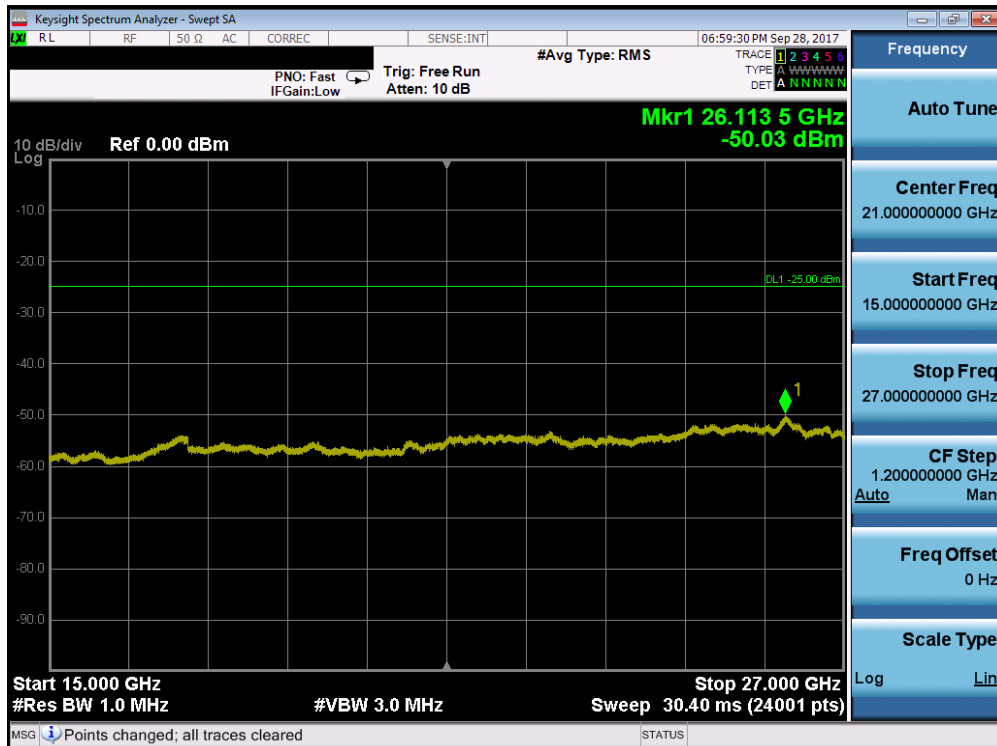


Plot 7-24. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 34 of 74

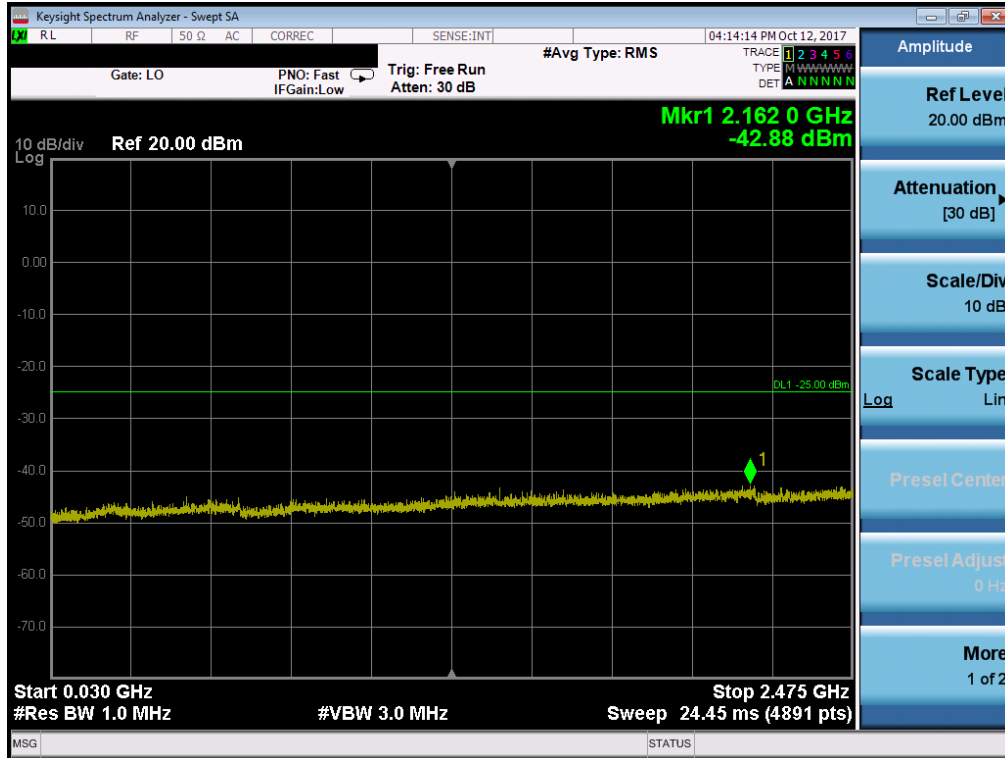


Plot 7-25. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

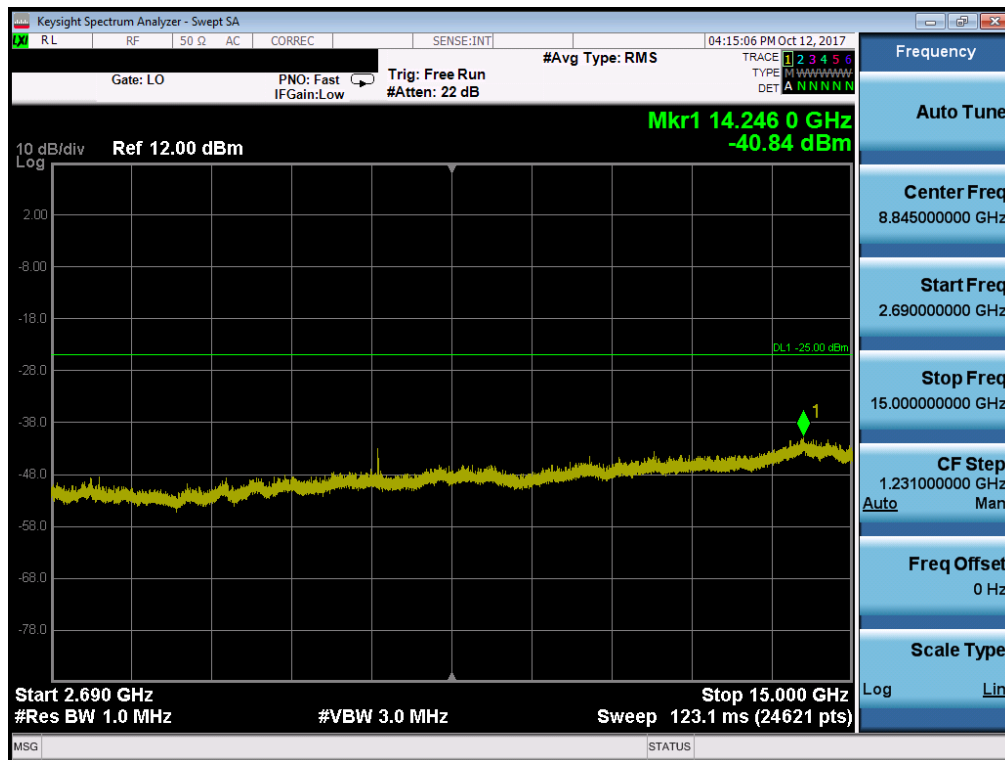


Plot 7-26. Conducted Spurious Plot (Band 7 - 10.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 35 of 74



Plot 7-27. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

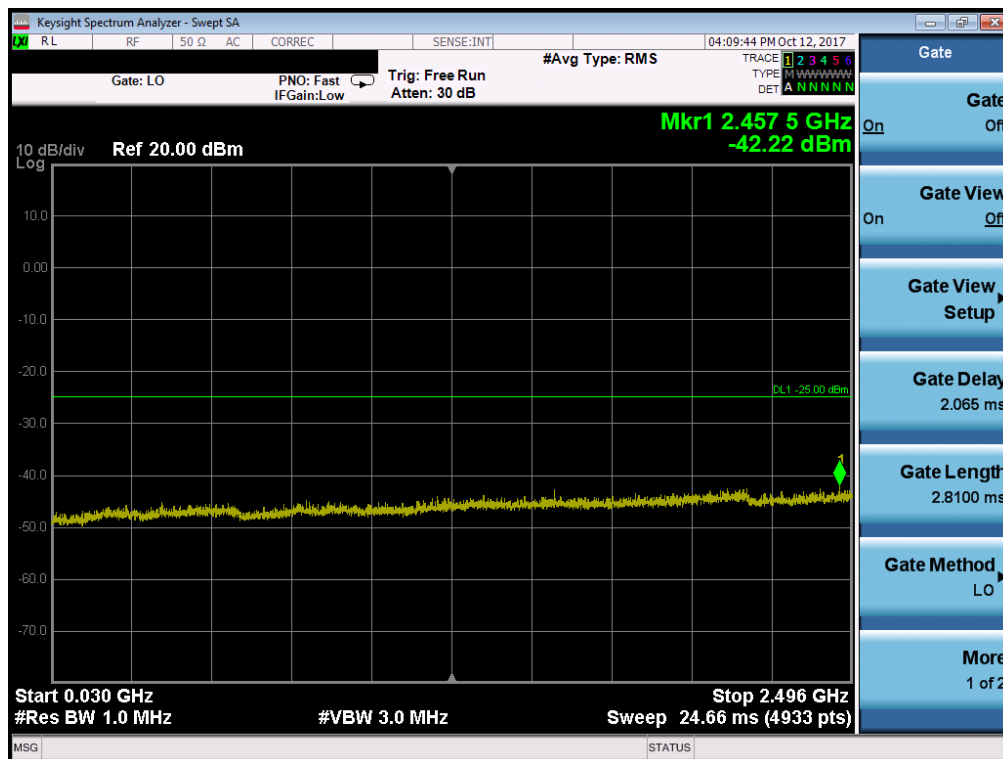


Plot 7-28. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 36 of 74



Plot 7-29. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)



Plot 7-30. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 37 of 74

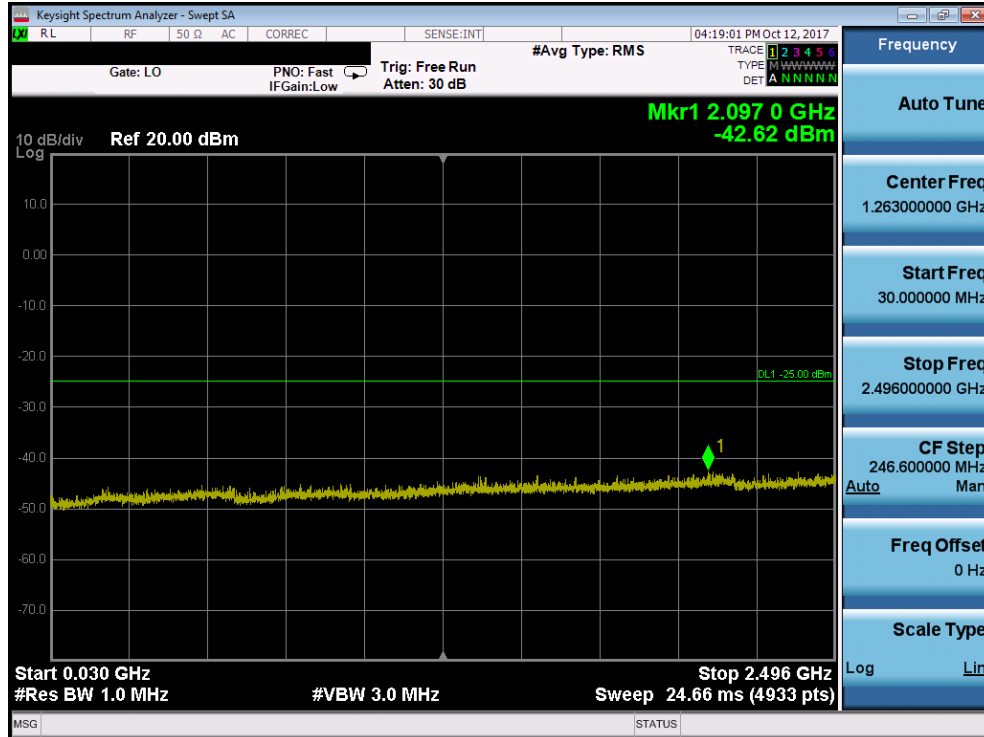


Plot 7-31. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

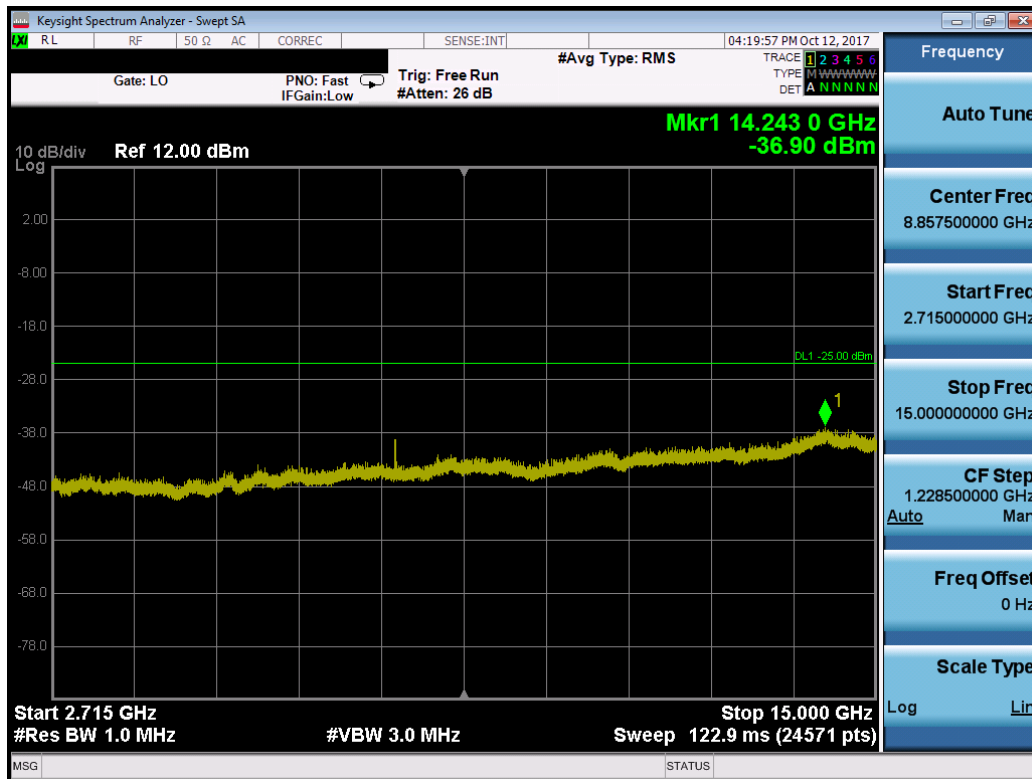


Plot 7-32. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – Mid Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 38 of 74



Plot 7-33. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)



Plot 7-34. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 39 of 74



Plot 7-35. Conducted Spurious Plot (Band 38 – 10.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 40 of 74

7.4 Band Edge Emissions at Antenna Terminal

§2.1051 §22.917(a) §27.53(m) RSS-132(5.5) RSS-199(4.5)

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

The minimum permissible attenuation level for Band 7 and 38 is as noted in the Test Notes on the following page.

Test Procedure Used

KDB 971168 D01 v02r02 – Section 6.0

Test Settings

1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW $\geq 1\%$ of the emission bandwidth
4. VBW $\geq 3 \times$ RBW
5. Detector = RMS
6. Number of sweep points $\geq 2 \times$ Span/RBW
7. Trace mode = trace average for continuous emissions, max hold for pulse emissions
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

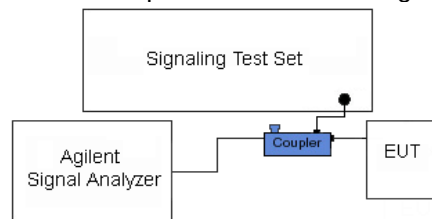


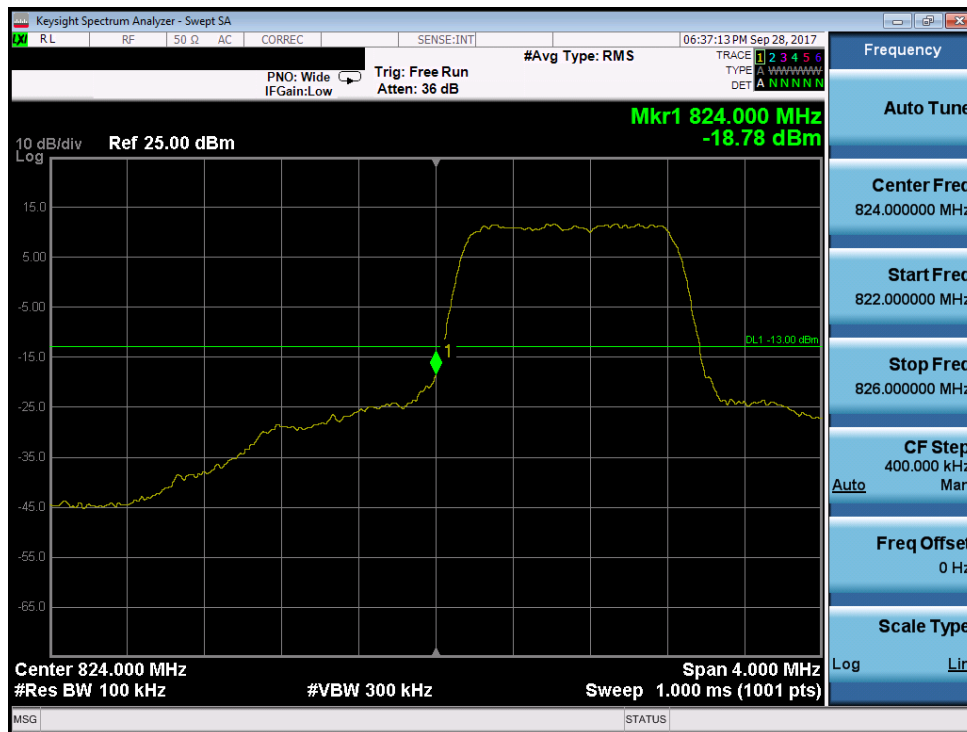
Figure 7-3. Test Instrument & Measurement Setup

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 41 of 74

Test Notes

Per 22.917(b), RSS-132(5.5), and RSS-199(4.5) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

Per 27.53(m) and RSS-199(4.5) for operations in the BRS/EBS bands, the attenuation factor shall be not less than $40 + 10 \log (P)$ dB on all frequencies between the channel edge and 5 megahertz from the channel edge, $43 + 10 \log (P)$ dB on all frequencies between 5 megahertz and X megahertz from the channel edge, and $55 + 10 \log (P)$ dB on all frequencies more than X megahertz from the channel edge, where X is the greater of 6 megahertz or the actual emission bandwidth. In addition, the attenuation factor shall not be less than $43 + 10 \log (P)$ dB on all frequencies between 2490.5 MHz and 2496 MHz and $55 + 10 \log (P)$ dB at or below 2490.5 MHz.

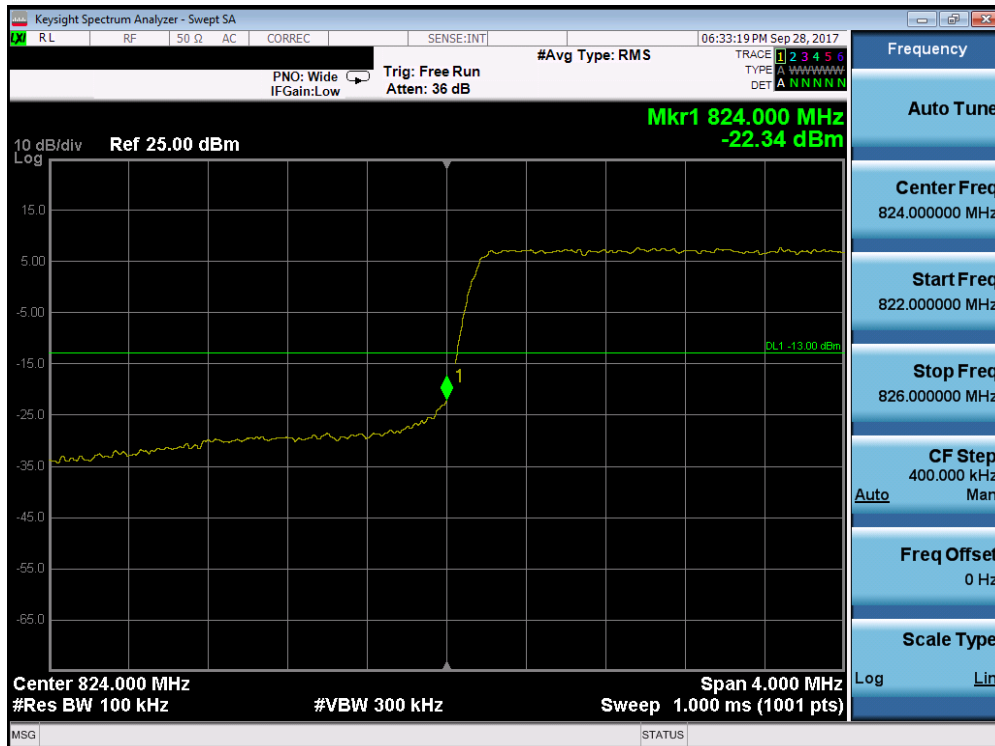


Plot 7-36. Lower Band Edge Plot (Band 5 – 1.4MHz QPSK - RB Size 6)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 42 of 74



Plot 7-37. Upper Band Edge Plot (Band 5 – 1.4MHz QPSK - RB Size 6)

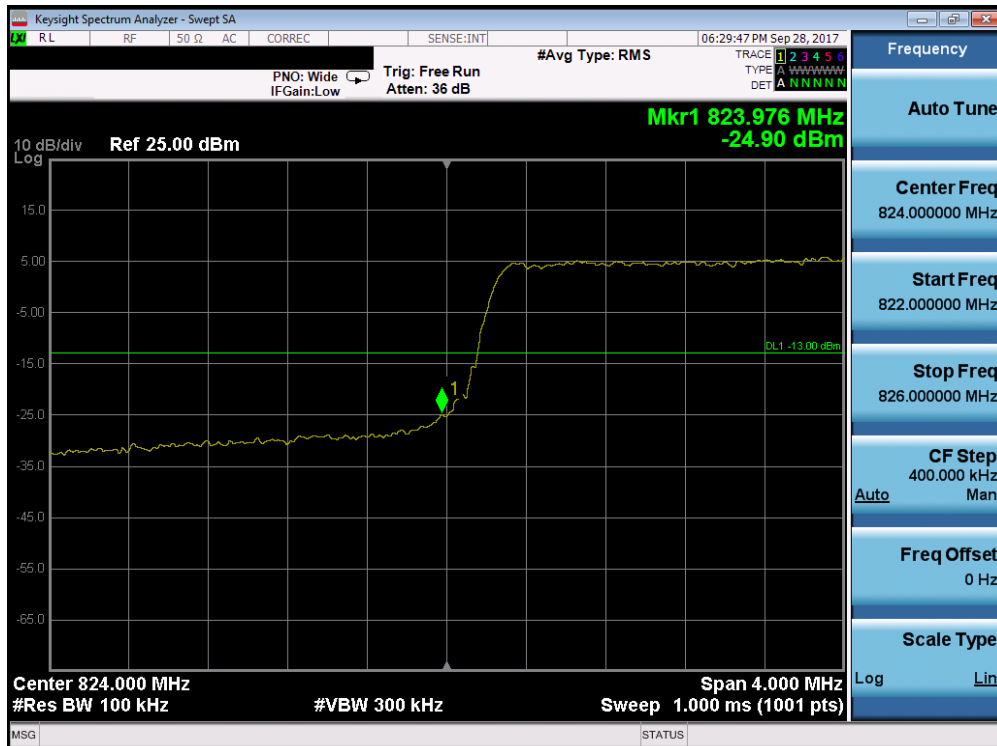


Plot 7-38. Lower Band Edge Plot (Band 5 - 3.0MHz QPSK - RB Size 15)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 43 of 74



Plot 7-39. Upper Band Edge Plot (Band 5 - 3.0MHz QPSK - RB Size 15)

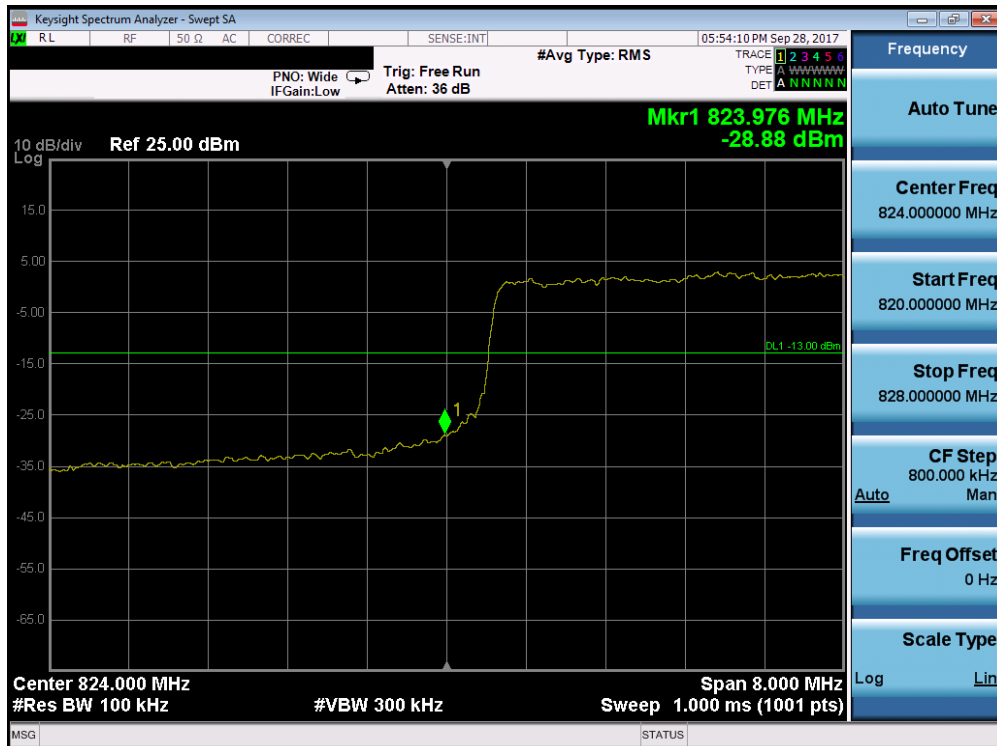


Plot 7-40. Lower Band Edge Plot (Band 5 - 5.0MHz QPSK - 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 44 of 74



Plot 7-41. Upper Band Edge Plot (Band 5 - 5.0MHz QPSK - RB Size 25)

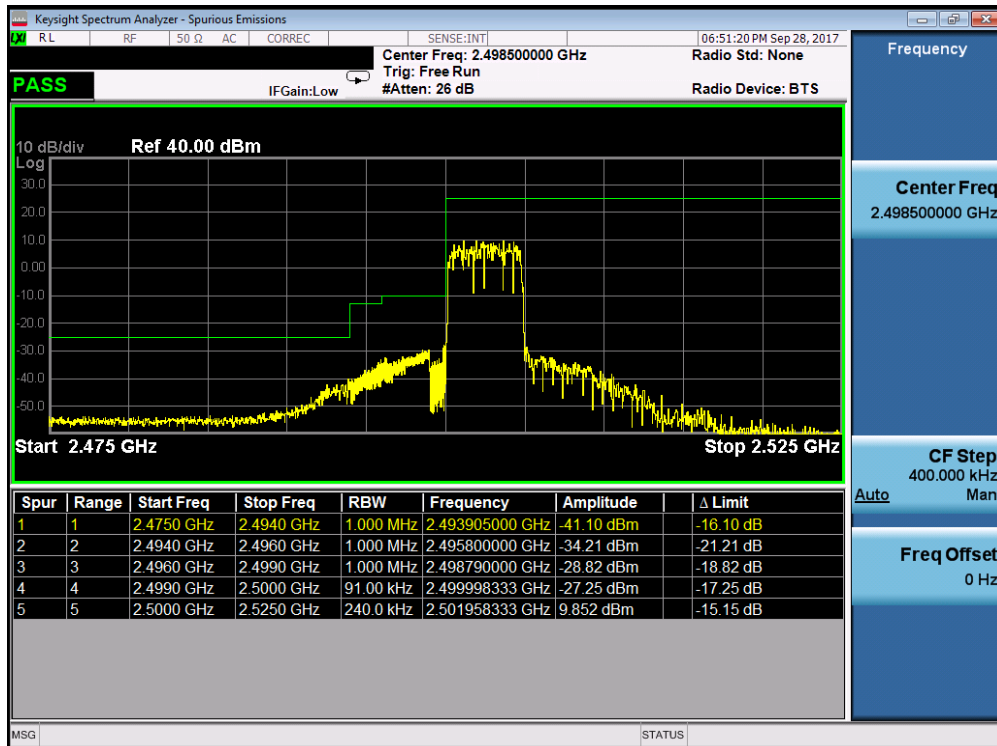


Plot 7-42. Lower Band Edge Plot (Band 5 - 10.0MHz QPSK - RB Size 50)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 45 of 74

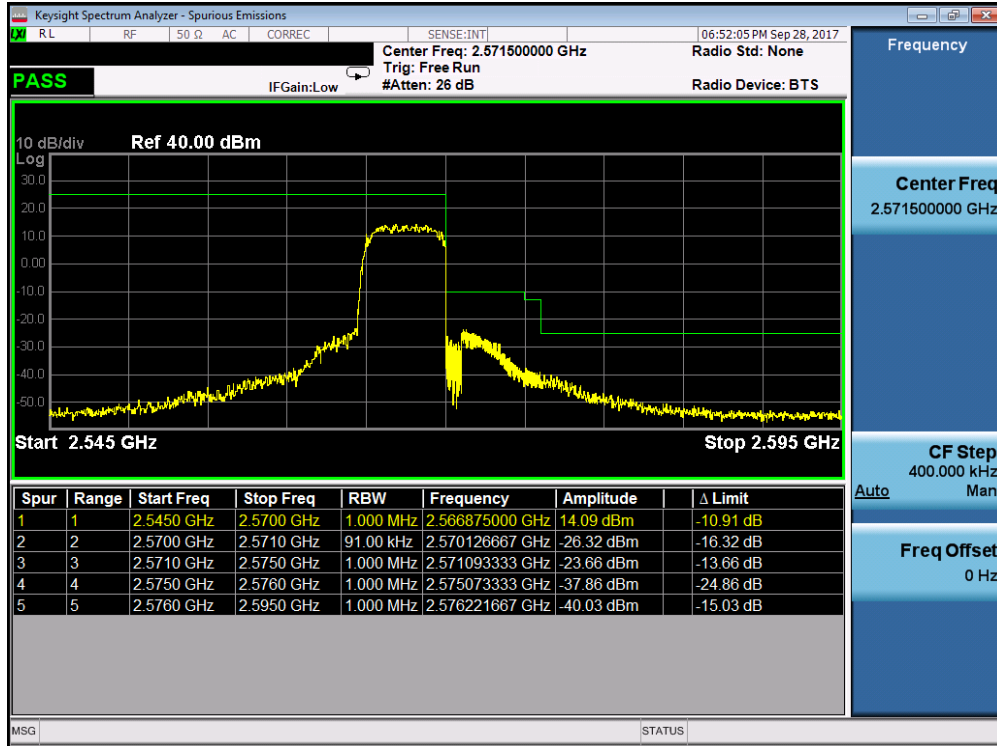


Plot 7-43. Upper Band Edge Plot (Band 5 - 10.0MHz QPSK - RB Size 50)

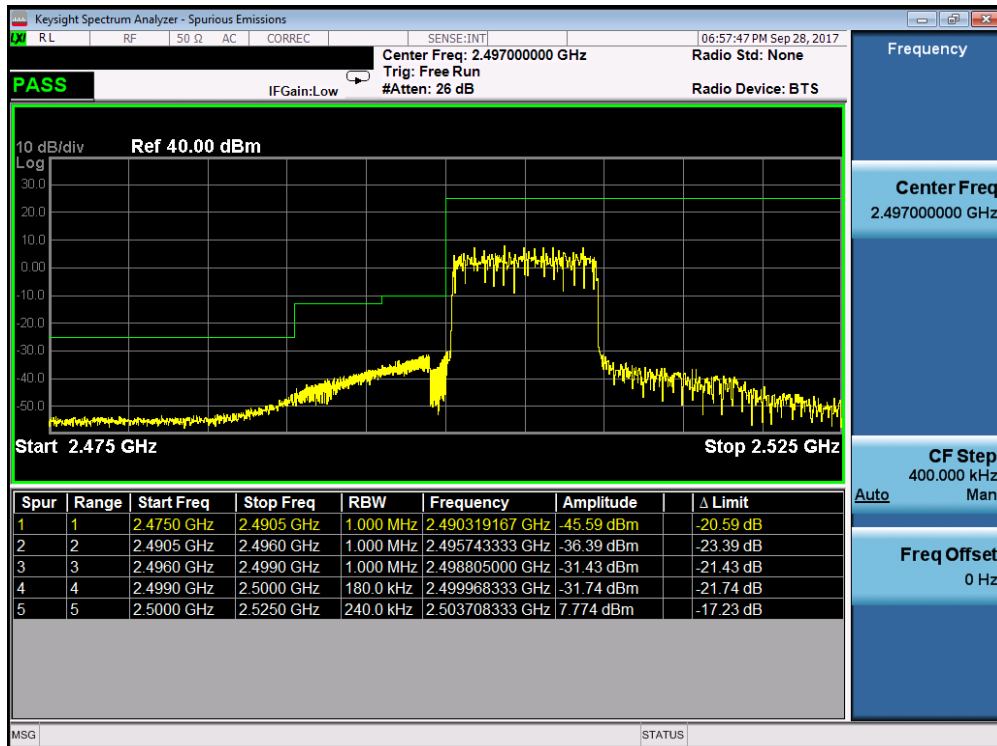


Plot 7-44. Lower ACP Plot (Band 7 - 5.0MHz QPSK - RB Size 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 46 of 74

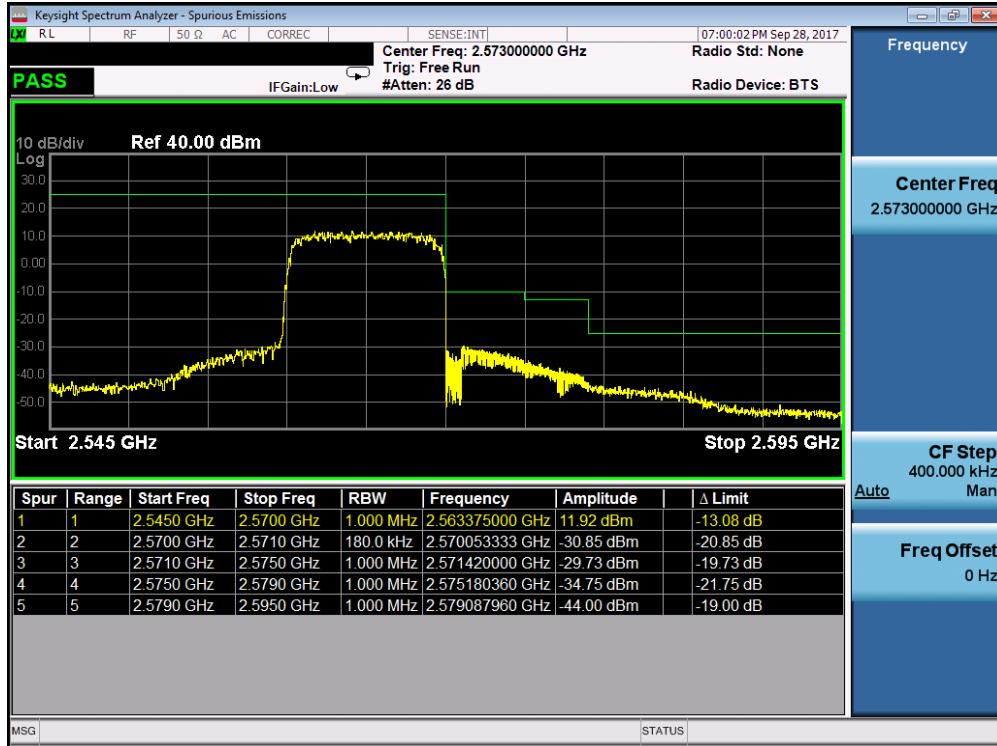


Plot 7-45. Upper ACP Plot (Band 7 - 5.0MHz QPSK - RB Size 25)

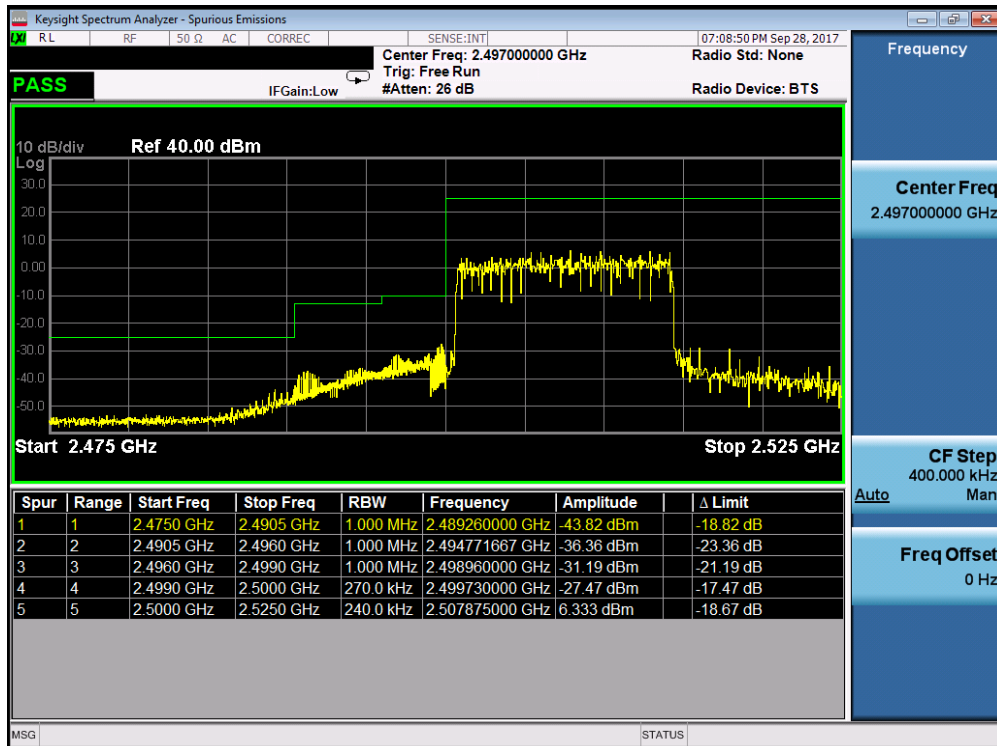


Plot 7-46. Lower ACP Plot (Band 7 - 10.0MHz QPSK - RB Size 50)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 47 of 74

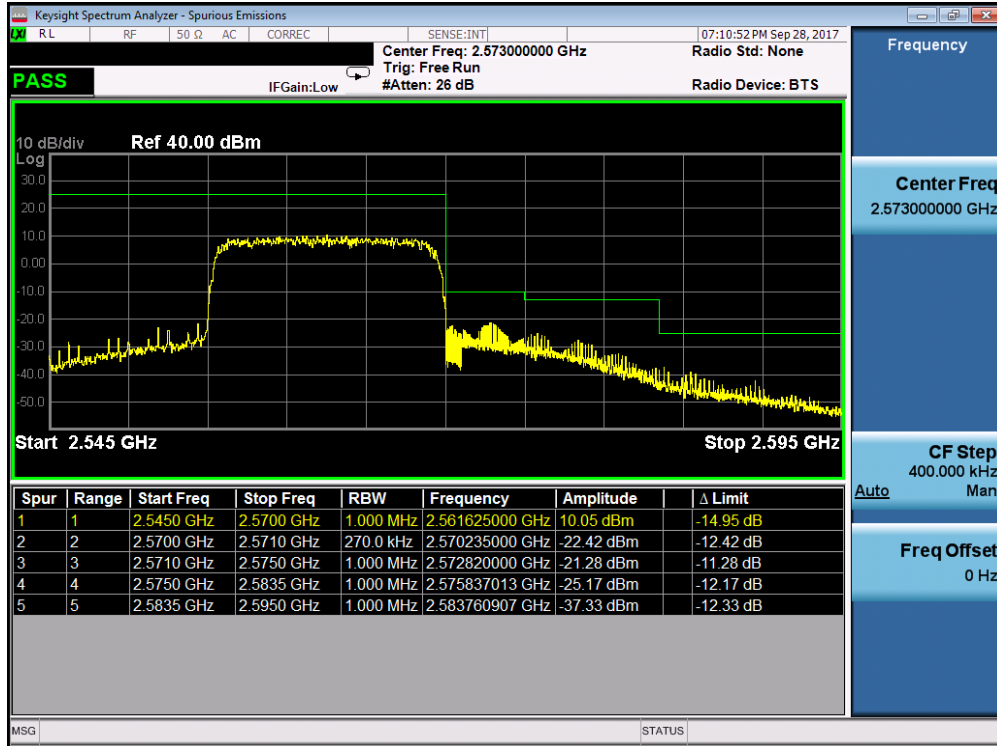


Plot 7-47. Upper ACP Plot (Band 7 - 10.0MHz QPSK - RB Size 50)

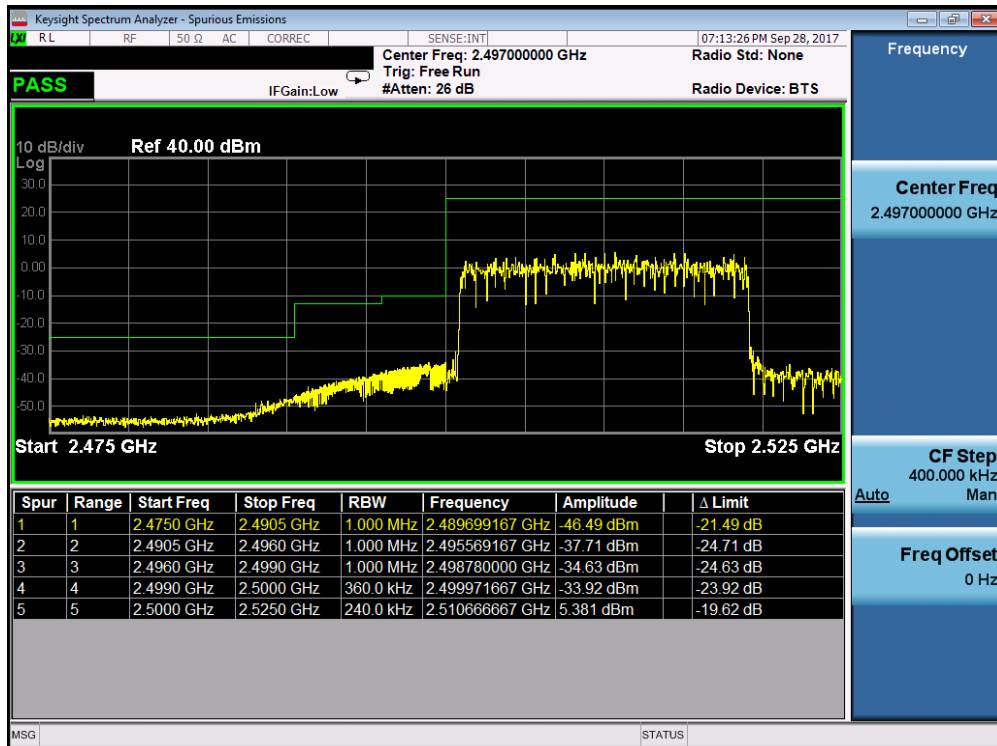


Plot 7-48. Lower ACP Plot (Band 7 - 15.0MHz QPSK - RB Size 75)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 48 of 74

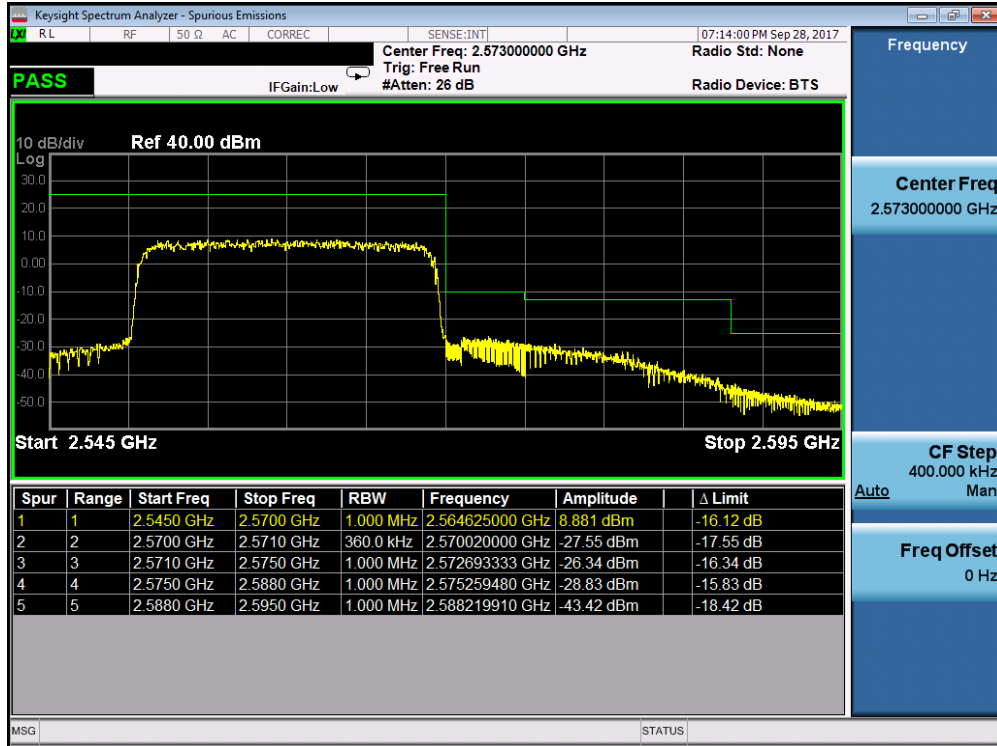


Plot 7-49. Upper ACP Plot (Band 7 - 15.0MHz QPSK - RB Size 75)

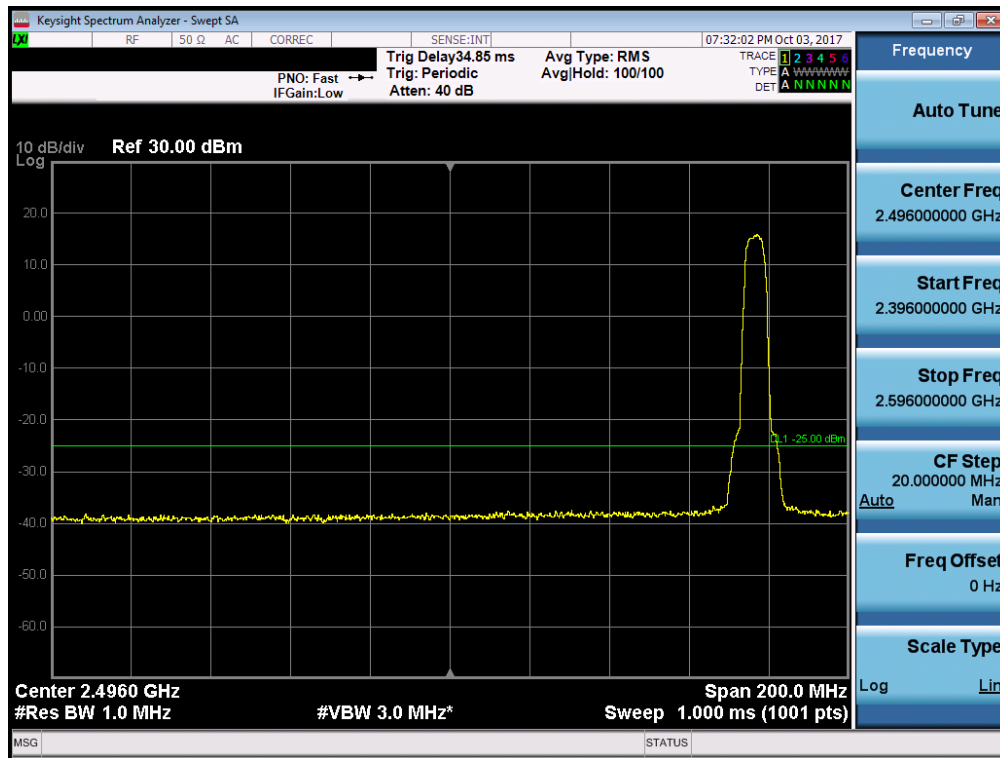


Plot 7-50. Lower ACP Plot (Band 7 - 20.0MHz QPSK - RB Size 100)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 49 of 74

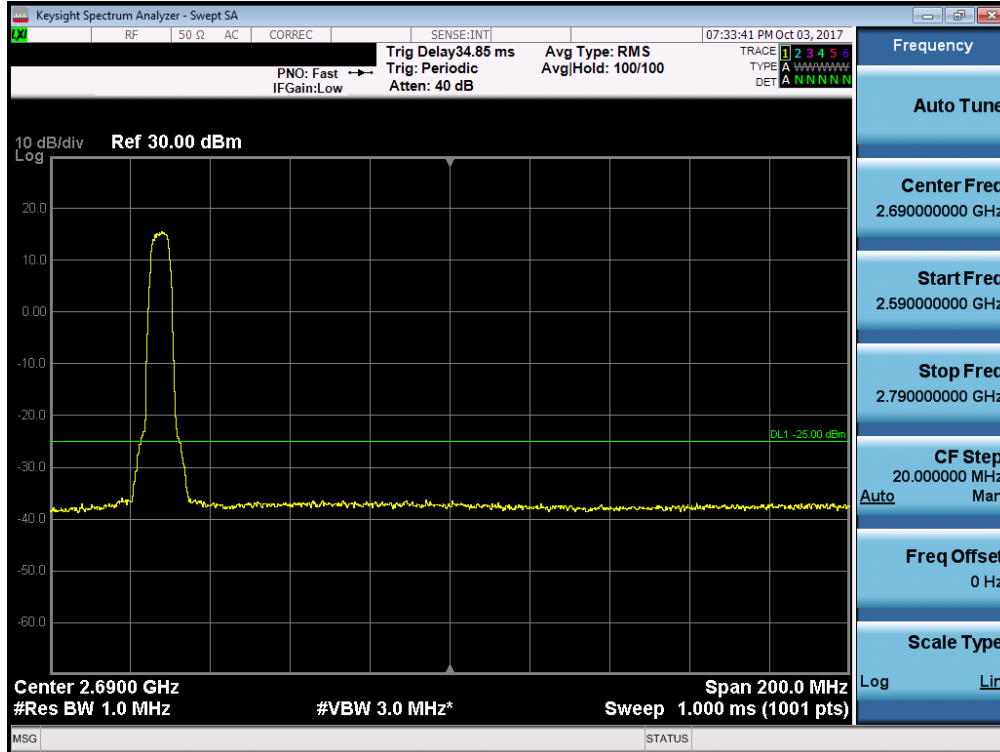


Plot 7-51. Upper ACP Plot (Band 7 - 20.0MHz QPSK - RB Size 100)

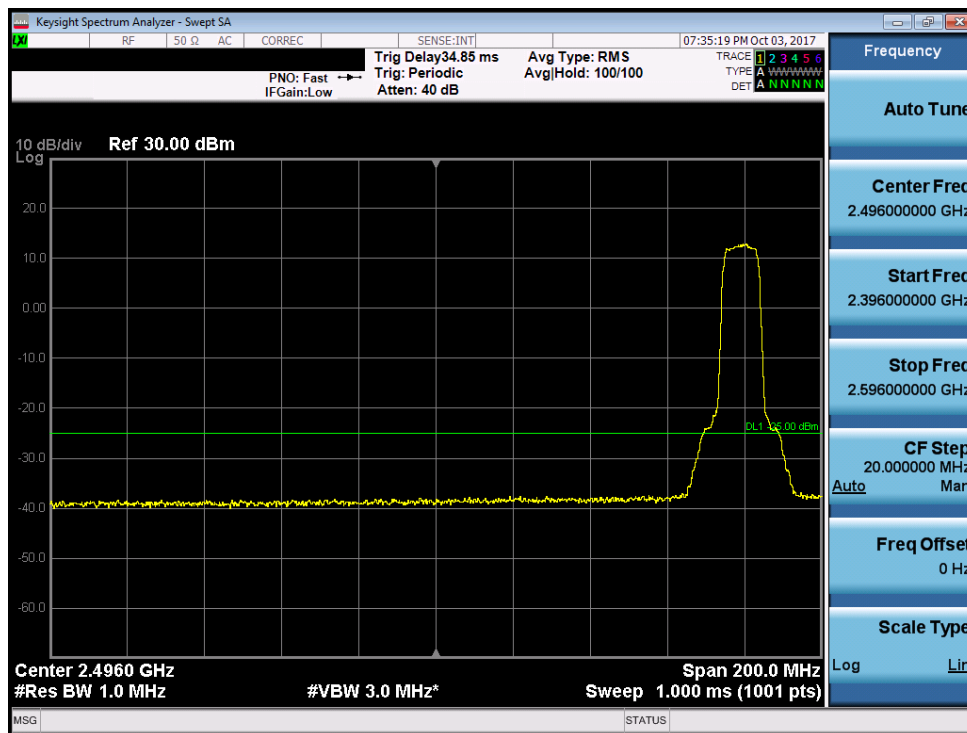


Plot 7-52. Lower Band Edge Plot (Band 38- 5.0MHz QPSK - RB Size 25)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 50 of 74

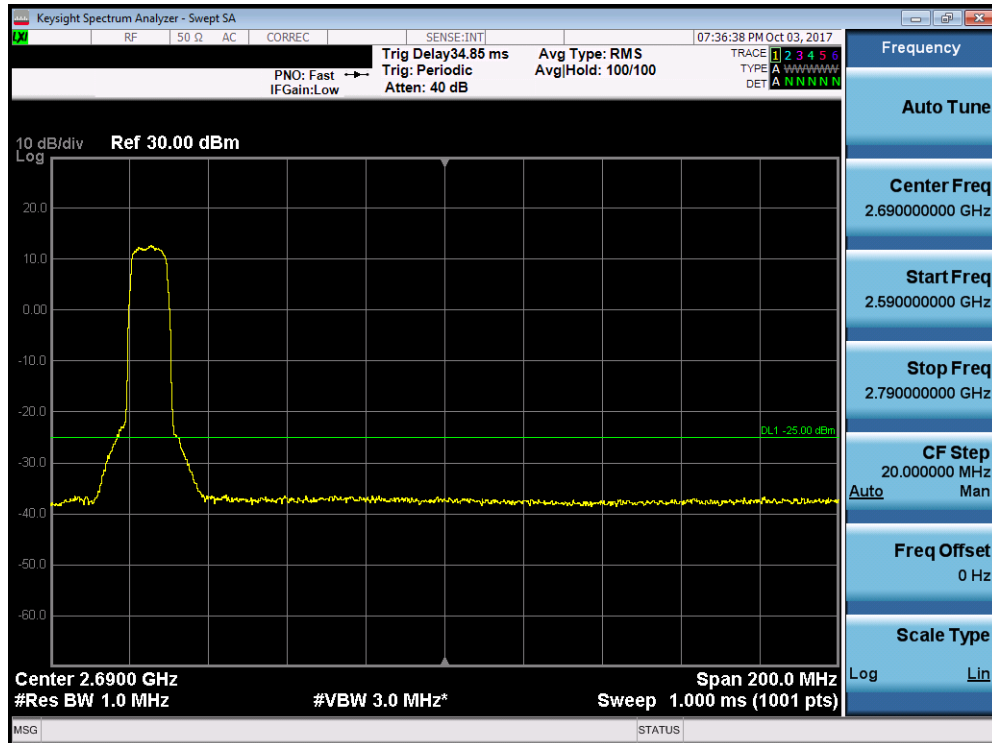


Plot 7-53. Upper Band Edge Plot (Band 38 – 5.0MHz QPSK – RB Size 25)



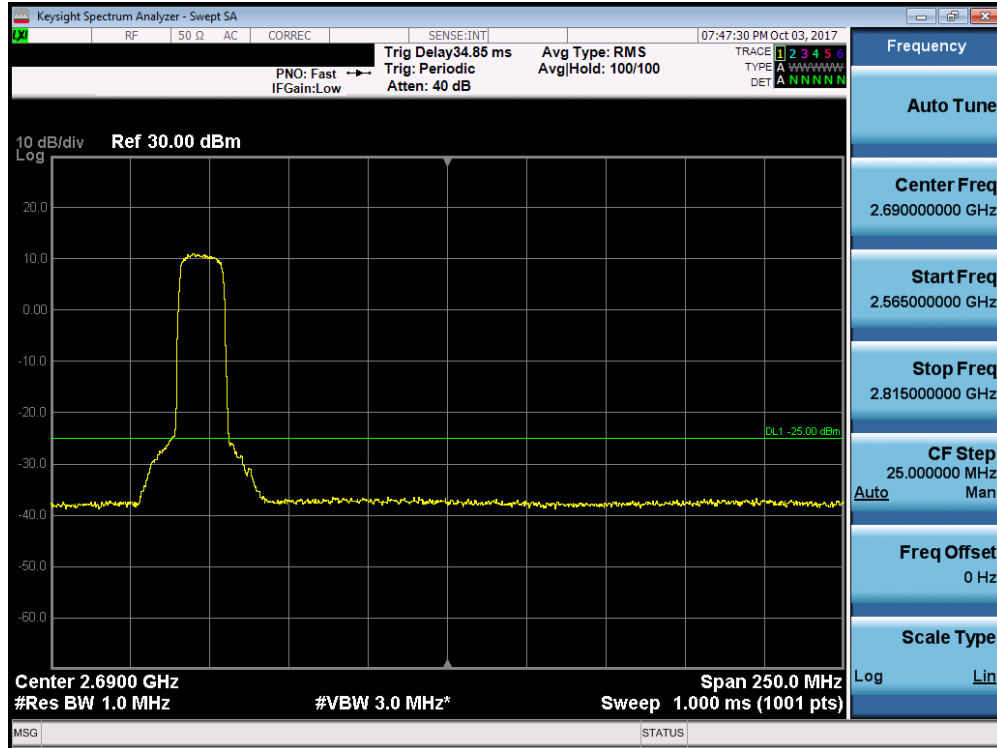
Plot 7-54. Lower Band Edge Plot (Band 38 – 10.0MHz QPSK – RB Size 50)

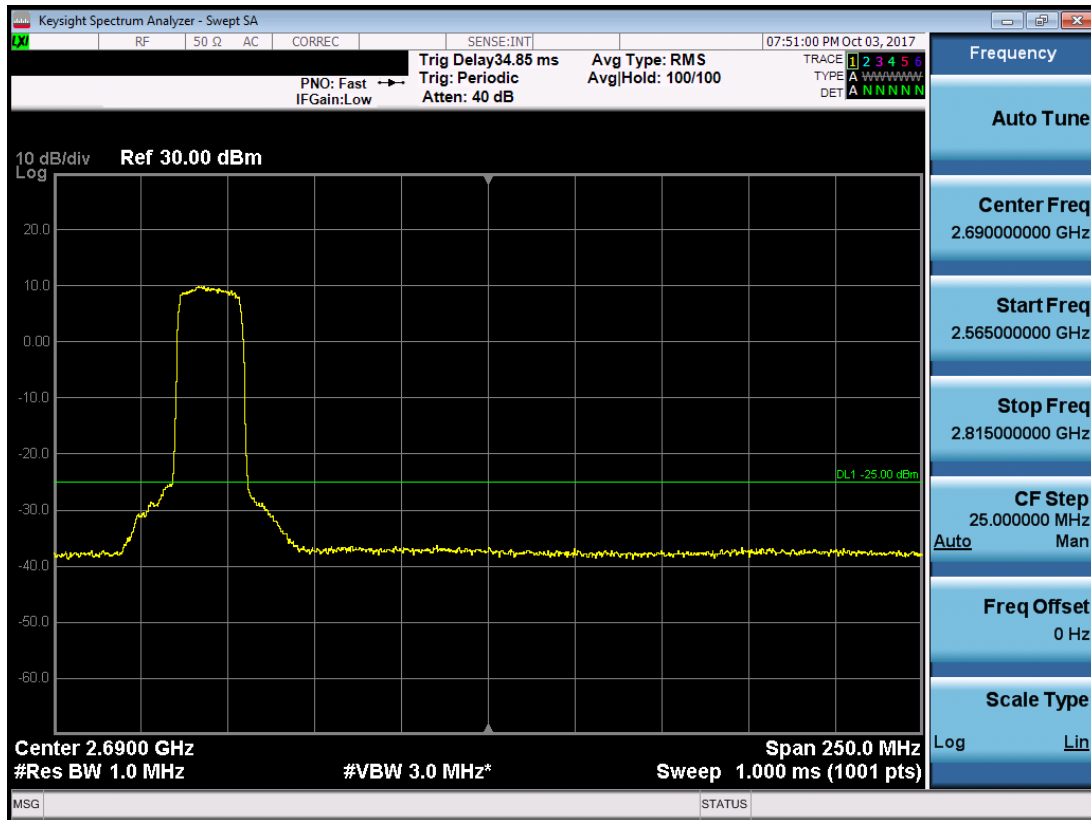
FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 51 of 74



Plot 7-55. Upper Band Edge Plot (Band 38 – 10.0MHz QPSK – RB Size 50)

Plot 7-56. Lower Band Edge Plot (Band 38 – 15.0MHz QPSK – RB Size 75)





Plot 7-59. Upper Band Edge Plot (Band 38 – 20.0MHz QPSK – RB Size 100)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset		Page 54 of 74

7.5 Radiated Power (ERP/EIRP)

§22.913(a)(2) §27.50(h)(2) §27.50(a)(3) RSS-132(5.4) RSS-199(4.4)

Test Overview

Effective Radiated Power (ERP) and Equivalent Isotropic Radiated Power (EIRP) measurements are performed using the substitution method described in ANSI/TIA-603-E-2016 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using vertically and horizontally polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

Test Procedures Used

KDB 971168 D01 v02r02 – Section 5.2.1

ANSI/TIA-603-E-2016 – Section 2.2.17

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation. For signals with burst transmission, the signal analyzer's "time domain power" measurement capability is used
2. RBW = 1 – 5% of the expected OBW, not to exceed 1MHz
3. VBW $\geq 3 \times$ RBW
4. Span = 1.5 times the OBW
5. No. of sweep points $\geq 2 \times$ span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto". Trigger is set to enable triggering only on full power bursts with the sweep time set less than or equal to the transmission burst duration
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation. For signals with burst transmission, the "gating" function was enabled to ensure that measurements are performed during times in which the transmitter is operating at its maximum power
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset	Page 55 of 74	

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

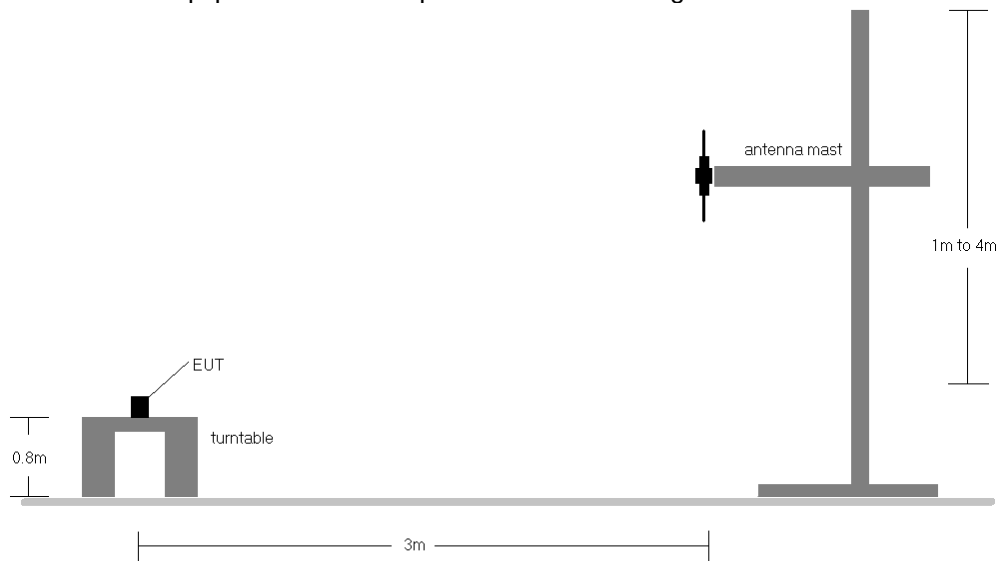


Figure 7-4. Radiated Test Setup <1GHz

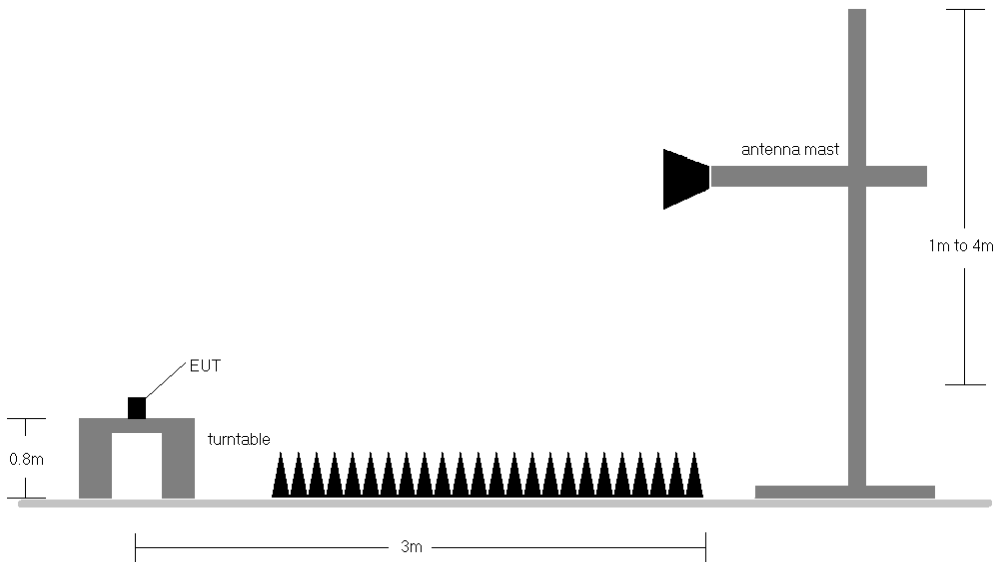


Figure 7-5. Radiated Test Setup >1GHz

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	ERP [dBm]	ERP [Watts]	ERP Limit [dBm]	Margin [dB]	EIRP [dBm]	EIRP [Watts]	Margin [dB]
824.70	1.4	QPSK	H	150	341	1 / 5	21.78	1.50	21.13	0.130	38.45	-17.32	23.28	0.213	-13.71
836.50	1.4	QPSK	H	150	336	1 / 5	21.02	1.50	20.37	0.109	38.45	-18.08	22.52	0.179	-14.47
848.30	1.4	QPSK	H	150	335	1 / 5	22.38	1.50	21.73	0.149	38.45	-16.72	23.88	0.244	-13.11
848.30	1.4	16-QAM	H	150	335	1 / 5	20.34	1.50	19.69	0.093	38.45	-18.76	21.84	0.153	-15.15
825.50	3	QPSK	H	150	334	1 / 14	21.55	1.50	20.90	0.123	38.45	-17.55	23.05	0.202	-13.94
836.50	3	QPSK	H	150	340	1 / 14	21.24	1.50	20.59	0.115	38.45	-17.86	22.74	0.188	-14.25
847.50	3	QPSK	H	150	336	1 / 14	22.28	1.50	21.63	0.146	38.45	-16.82	23.78	0.239	-13.21
847.50	3	16-QAM	H	150	336	1 / 14	21.02	1.50	20.37	0.109	38.45	-18.08	22.52	0.179	-14.47
826.50	5	QPSK	H	150	340	1 / 24	21.88	1.50	21.23	0.133	38.45	-17.22	23.38	0.218	-13.61
836.50	5	QPSK	H	150	345	1 / 24	21.49	1.50	20.84	0.121	38.45	-17.61	22.99	0.199	-14.00
846.50	5	QPSK	H	150	337	1 / 24	22.50	1.50	21.85	0.153	38.45	-16.60	24.00	0.251	-12.99
846.50	5	16-QAM	H	150	337	1 / 24	20.38	1.50	19.73	0.094	38.45	-18.72	21.88	0.154	-15.11
829.00	10	QPSK	H	150	335	1 / 0	21.60	1.50	20.95	0.124	38.45	-17.50	23.10	0.204	-13.89
836.50	10	QPSK	H	150	340	1 / 49	21.79	1.50	21.14	0.130	38.45	-17.31	23.29	0.213	-13.70
844.00	10	QPSK	H	150	337	1 / 49	22.07	1.50	21.42	0.139	38.45	-17.03	23.57	0.228	-13.42
844.00	10	16-QAM	H	150	337	1 / 49	21.09	1.50	20.44	0.111	38.45	-18.01	22.59	0.182	-14.40
846.50	5	QPSK	V	150	354	1 / 74	21.48	1.50	20.83	0.121	38.45	-17.62	22.98	0.199	-14.01

Table 7-19. ERP/EIRP Data (Band 5)

FCC ID: A3LSMJ250F	 FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION) 		Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset	Page 57 of 74

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	EIRP [dBm]	EIRP [Watts]	EIRP Limit [dBm]	Margin [dB]
2502.50	5	QPSK	H	150	125	1 / 0	17.38	5.74	23.12	0.205	33.01	-9.89
2535.00	5	QPSK	H	150	122	1 / 24	16.65	5.86	22.51	0.178	33.01	-10.50
2567.50	5	QPSK	H	150	119	1 / 0	16.21	5.98	22.19	0.166	33.01	-10.82
2502.50	5	16-QAM	H	150	125	1 / 0	16.50	5.74	22.24	0.167	33.01	-10.77
2505.00	10	QPSK	H	150	125	1 / 0	17.39	5.75	23.14	0.206	33.01	-9.87
2535.00	10	QPSK	H	150	130	1 / 0	16.51	5.86	22.37	0.173	33.01	-10.64
2565.00	10	QPSK	H	150	125	1 / 0	16.52	5.97	22.49	0.177	33.01	-10.52
2505.00	10	16-QAM	H	150	125	1 / 0	16.24	5.75	21.99	0.158	33.01	-11.02
2507.50	15	QPSK	H	150	356	1 / 0	17.20	5.76	22.96	0.198	33.01	-10.05
2535.00	15	QPSK	H	150	10	1 / 74	16.80	5.86	22.66	0.185	33.01	-10.35
2562.50	15	QPSK	H	150	129	1 / 0	16.63	5.96	22.59	0.182	33.01	-10.42
2562.50	15	16-QAM	H	150	129	1 / 0	15.93	5.96	21.89	0.155	33.01	-11.12
2510.00	20	QPSK	H	150	116	1 / 99	16.76	5.77	22.53	0.179	33.01	-10.48
2535.00	20	QPSK	H	150	135	1 / 99	16.64	5.86	22.50	0.178	33.01	-10.51
2560.00	20	QPSK	H	150	135	1 / 99	15.86	5.95	21.81	0.152	33.01	-11.20
2510.00	20	16-QAM	H	150	116	1 / 99	15.30	5.77	21.07	0.128	33.01	-11.94
2505.00	10	QPSK	V	150	129	1 / 0	15.38	5.75	21.13	0.130	33.01	-11.88

Table 7-20. EIRP Data (Band 7)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	EIRP [dBm]	EIRP [Watts]	EIRP Limit [dBm]	Margin [dB]
2572.50	5	QPSK	V	150	60	1 / 0	14.21	6.00	20.21	0.105	33.01	-12.80
2595.00	5	QPSK	V	150	63	1 / 0	18.55	6.08	24.63	0.290	33.01	-8.38
2617.50	5	QPSK	V	150	68	1 / 0	13.30	6.18	19.48	0.089	33.01	-13.53
2595.00	5	16-QAM	V	150	63	1 / 0	16.76	6.08	22.84	0.192	33.01	-10.17
2575.00	10	QPSK	V	150	69	1 / 49	17.18	6.01	23.19	0.208	33.01	-9.82
2595.00	10	QPSK	V	150	67	25 / 12	16.68	6.08	22.76	0.189	33.01	-10.25
2615.00	10	QPSK	V	150	63	1 / 49	17.03	6.17	23.20	0.209	33.01	-9.82
2575.00	10	16-QAM	V	150	69	1 / 49	15.18	6.01	21.19	0.131	33.01	-11.82
2577.50	15	QPSK	V	150	66	1 / 74	18.46	6.02	24.48	0.280	33.01	-8.53
2595.00	15	QPSK	V	150	66	1 / 0	17.78	6.08	23.86	0.243	33.01	-9.15
2612.50	15	QPSK	V	150	92	1 / 0	18.71	6.15	24.86	0.306	33.01	-8.15
2612.50	15	16-QAM	V	150	92	1 / 0	17.25	6.15	23.40	0.219	33.01	-9.61
2580.00	20	QPSK	V	150	174	1 / 0	15.40	6.03	21.43	0.139	33.01	-11.58
2595.00	20	QPSK	V	150	67	1 / 0	16.68	6.08	22.76	0.189	33.01	-10.25
2610.00	20	QPSK	V	150	163	1 / 0	13.85	6.14	19.99	0.100	33.01	-13.02
2595.00	20	16-QAM	V	150	67	1 / 0	14.34	6.08	20.42	0.110	33.01	-12.59
2612.50	15	QPSK	H	150	115	1 / 0	16.75	6.15	22.90	0.195	33.01	-10.11

Table 7-21. EIRP Data (Band 38)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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7.6 Radiated Spurious Emissions Measurements

§2.1053 §22.917(a) §27.53(m) RSS-132(5.5) RSS-199(4.5)

Test Overview

Radiated spurious emissions measurements are performed using the substitution method described in ANSI/TIA-603-E-2016 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using vertically and horizontally polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas.

Test Procedures Used

KDB 971168 D01 v02r02 – Section 5.8

ANSI/TIA-603-E-2016 – Section 2.2.12

Test Settings

1. RBW = 100kHz for emissions below 1GHz and 1MHz for emissions above 1GHz
2. VBW $\geq 3 \times$ RBW
3. Span = 1.5 times the OBW
4. No. of sweep points $\geq 2 \times$ span / RBW
5. Detector = RMS
6. Trace mode = Average (Max Hold for pulsed emissions)
7. The trace was allowed to stabilize

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

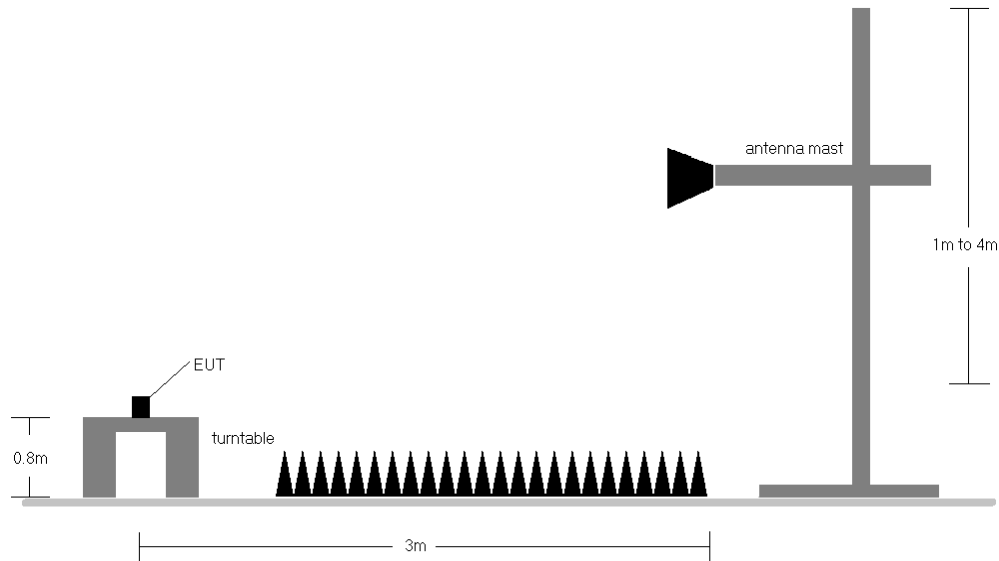


Figure 7-6. Test Instrument & Measurement Setup

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.
- 3) The spectrum is measured from 9kHz to the 10th harmonic of the fundamental frequency of the transmitter. The worst-case emissions are reported.
- 4) Emissions below 18GHz were measured at a 3 meter test distance while emissions above 18GHz were measured at a 1 meter test distance with the application of a distance correction factor.
- 5) The "-" shown in the following RSE tables are used to denote a noise floor measurement.

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OPERATING FREQUENCY: 826.50 MHz
CHANNEL: 20450
MODULATION SIGNAL: QPSK
BANDWIDTH: 5.0 MHz
DISTANCE: 3 meters
LIMIT: -13 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
1653.00	H	133	21	-45.05	8.96	-36.09	-23.1
2479.50	H	100	61	-57.44	9.13	-48.31	-35.3
3306.00	H	160	314	-69.38	9.36	-60.01	-47.0
4132.50	H	178	145	-61.60	9.95	-51.65	-38.7
4959.00	H	100	171	-58.34	11.22	-47.12	-34.1
5785.50	H	183	155	-72.06	11.36	-60.70	-47.7
6612.00	H	-	-	-69.59	11.17	-58.42	-45.4

Table 7-22. Radiated Spurious Data (Band 5 – Low Channel)

OPERATING FREQUENCY: 836.50 MHz
CHANNEL: 20525
MODULATION SIGNAL: QPSK
BANDWIDTH: 5.0 MHz
DISTANCE: 3 meters
LIMIT: -13 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
1673.00	H	123	17	-46.16	8.85	-37.31	-24.3
2509.50	H	104	304	-59.66	9.17	-50.49	-37.5
3346.00	H	155	322	-72.31	9.36	-62.95	-49.9
4182.50	H	173	145	-66.12	10.19	-55.93	-42.9
5019.00	H	100	174	-59.39	11.10	-48.29	-35.3
5855.50	H	155	79	-72.82	11.32	-61.49	-48.5
6692.00	H	-	-	-69.66	10.94	-58.73	-45.7

Table 7-23. Radiated Spurious Data (Band 5 – Mid Channel)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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OPERATING FREQUENCY: 846.50 MHz
CHANNEL: 20600
MODULATION SIGNAL: QPSK
BANDWIDTH: 5.0 MHz
DISTANCE: 3 meters
LIMIT: -13 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
1693.00	H	118	21	-42.66	8.74	-33.92	-20.9
2539.50	H	128	345	-63.72	9.24	-54.49	-41.5
3386.00	H	100	331	-71.12	9.42	-61.70	-48.7
4232.50	H	178	145	-62.65	10.38	-52.27	-39.3
5079.00	H	151	87	-59.79	10.92	-48.87	-35.9
5925.50	H	146	160	-71.62	11.25	-60.37	-47.4
6772.00	H	-	-	-68.69	10.82	-57.88	-44.9

Table 7-24. Radiated Spurious Data (Band 5 – High Channel)

OPERATING FREQUENCY: 2505.00 MHz
CHANNEL: 20800
MODULATION SIGNAL: QPSK
BANDWIDTH: 10.0 MHz
DISTANCE: 3 meters
LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5010.00	H	128	343	-66.00	11.14	-54.86	-29.9
7515.00	H	-	-	-59.66	11.02	-48.64	-23.6

Table 7-25. Radiated Spurious Data (Band 7 – Low Channel)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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OPERATING FREQUENCY: 2535.00 MHz
CHANNEL: 21100
MODULATION SIGNAL: QPSK
BANDWIDTH: 10.0 MHz
DISTANCE: 3 meters
LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5070.00	H	126	41	-59.82	10.91	-48.91	-23.9
7605.00	H	122	183	-54.01	11.22	-42.79	-17.8
10140.00	H	133	298	-54.84	12.28	-42.56	-17.6
12675.00	H	-	-	-56.31	12.91	-43.40	-18.4

Table 7-26. Radiated Spurious Data (Band 7 – Mid Channel)

OPERATING FREQUENCY: 2565.00 MHz
CHANNEL: 21400
MODULATION SIGNAL: QPSK
BANDWIDTH: 10.0 MHz
DISTANCE: 3 meters
LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5130.00	H	122	34	-56.49	10.82	-45.67	-20.7
7695.00	H	141	173	-52.79	11.36	-41.44	-16.4
10260.00	H	138	84	-55.90	12.44	-43.47	-18.5
12825.00	H	-	-	-55.22	12.86	-42.36	-17.4

Table 7-27. Radiated Spurious Data (Band 7 – High Channel)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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OPERATING FREQUENCY: 2577.50 MHz
 CHANNEL: 37800
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 15.0 MHz
 DISTANCE: 3 meters
 LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5155.00	H	100	179	-63.01	10.75	-52.25	-27.3
7732.50	H	100	178	-51.79	11.40	-40.39	-15.4
10310.00	H	-	-	-61.99	12.44	-49.55	-24.5

Table 7-28. Radiated Spurious Data (Band 38 – Low Channel)

OPERATING FREQUENCY: 2595.00 MHz
 CHANNEL: 38000
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 15.0 MHz
 DISTANCE: 3 meters
 LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5190.00	H	150	238	-63.75	10.75	-53.00	-28.0
7785.00	H	100	124	-53.74	11.40	-42.35	-17.3
10380.00	H	100	164	-56.29	12.61	-43.68	-18.7
12975.00	H	-	-	-59.04	13.36	-45.68	-20.7

Table 7-29. Radiated Spurious Data (Band 38 – Mid Channel)

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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OPERATING FREQUENCY: 2612.50 MHz
 CHANNEL: 38200
 MODULATION SIGNAL: QPSK
 BANDWIDTH: 15.0 MHz
 DISTANCE: 3 meters
 LIMIT: -25 dBm

Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBi]	Spurious Emission Level [dBm]	Margin [dB]
5225.00	H	110	179	-62.30	10.73	-51.57	-26.6
7837.50	H	150	182	-53.82	11.32	-42.49	-17.5
10450.00	H	100	180	-59.48	12.66	-46.82	-21.8
13062.50	H	-	-	-59.77	13.22	-46.55	-21.6

Table 7-30. Radiated Spurious Data (Band 38 – High Channel)

FCC ID: A3LSMJ250F	 FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION) 		Approved by: Quality Manager
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7.7 Frequency Stability / Temperature Variation

§2.1055 §22.355 §27.54 RSS-132(5.3) RSS-199(4.3)

Test Overview and Limit

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-E-2016. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

For Part 22, RSS-132 and RSS-133, the frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency. For Part 27, RSS-130, and RSS-199, the frequency stability shall be sufficient to ensure that the fundamental emission stays within the authorized frequency block.

Test Procedure Used

ANSI/TIA-603-E-2016

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Setup

The EUT was connected via an RF cable to a spectrum analyzer with the EUT placed inside an environmental chamber.

Test Notes

None

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Band 5 Frequency Stability Measurements

§2.1055 §22.355 RSS-132(5.3)

OPERATING FREQUENCY: 836,500,000 Hz
 CHANNEL: 20525
 REFERENCE VOLTAGE: 3.80 VDC
 DEVIATION LIMIT: ± 0.00025 % or 2.5 ppm

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	836,499,903	-97	-0.0000115
100 %		- 30	836,499,864	-136	-0.0000163
100 %		- 20	836,499,808	-192	-0.0000230
100 %		- 10	836,499,839	-161	-0.0000192
100 %		0	836,499,860	-140	-0.0000168
100 %		+ 10	836,499,837	-163	-0.0000195
100 %		+ 20	836,499,840	-160	-0.0000191
100 %		+ 30	836,499,946	-54	-0.0000065
100 %		+ 40	836,499,802	-198	-0.0000237
100 %		+ 50	836,499,907	-93	-0.0000111
BATT. ENDPOINT	3.40	+ 20	836,499,997	-3	-0.0000003

Table 7-31. Frequency Stability Data (Band 5)

FCC ID: A3LSMJ250F	 FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION) 		Approved by: Quality Manager
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Band 5 Frequency Stability Measurements

§2.1055 §22.355 RSS-132(5.3)

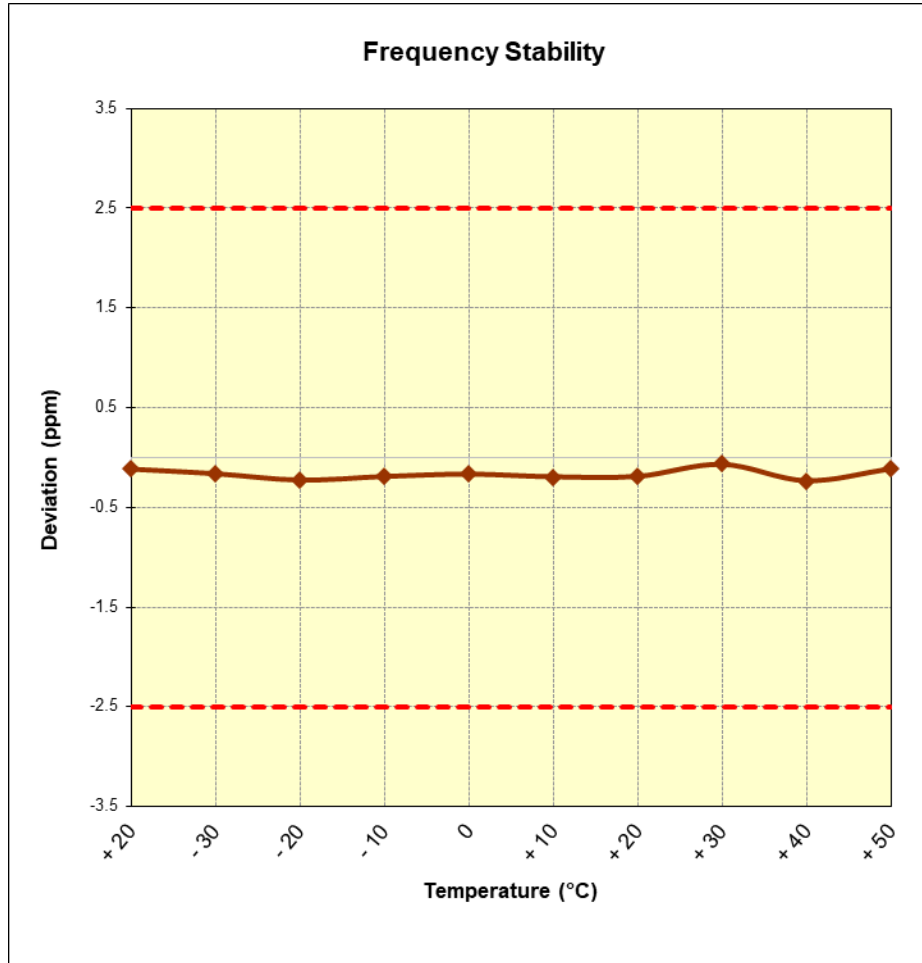


Figure 7-7. Frequency Stability Graph (Band 5)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Band 7 Frequency Stability Measurements

§2.1055 §27.54 RSS-199(4.3)

OPERATING FREQUENCY: 2,535,000,000 Hz
 CHANNEL: 21100
 REFERENCE VOLTAGE: 3.80 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	2,534,999,938	-62	-0.0000024
100 %		- 30	2,534,999,992	-8	-0.0000003
100 %		- 20	2,534,999,933	-67	-0.0000027
100 %		- 10	2,534,999,965	-35	-0.0000014
100 %		0	2,534,999,971	-29	-0.0000012
100 %		+ 10	2,534,999,970	-30	-0.0000012
100 %		+ 20	2,534,999,934	-66	-0.0000026
100 %		+ 30	2,534,999,834	-166	-0.0000066
100 %		+ 40	2,534,999,989	-11	-0.0000004
100 %		+ 50	2,534,999,889	-111	-0.0000044
BATT. ENDPOINT	3.40	+ 20	2,534,999,813	-187	-0.0000074

Table 7-32. Frequency Stability Data (Band 7)

Note:

Based on the results of the frequency stability test at the center channel the frequency deviation results measured are very small. As such it is determined that the channels at the band edge would remain in-band when the maximum measured frequency deviation noted during the frequency stability tests is applied. Therefore the device is determined to remain operating in band over the temperature and voltage range as tested.

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Band 7 Frequency Stability Measurements

§2.1055 §27.54 RSS-199(4.3)

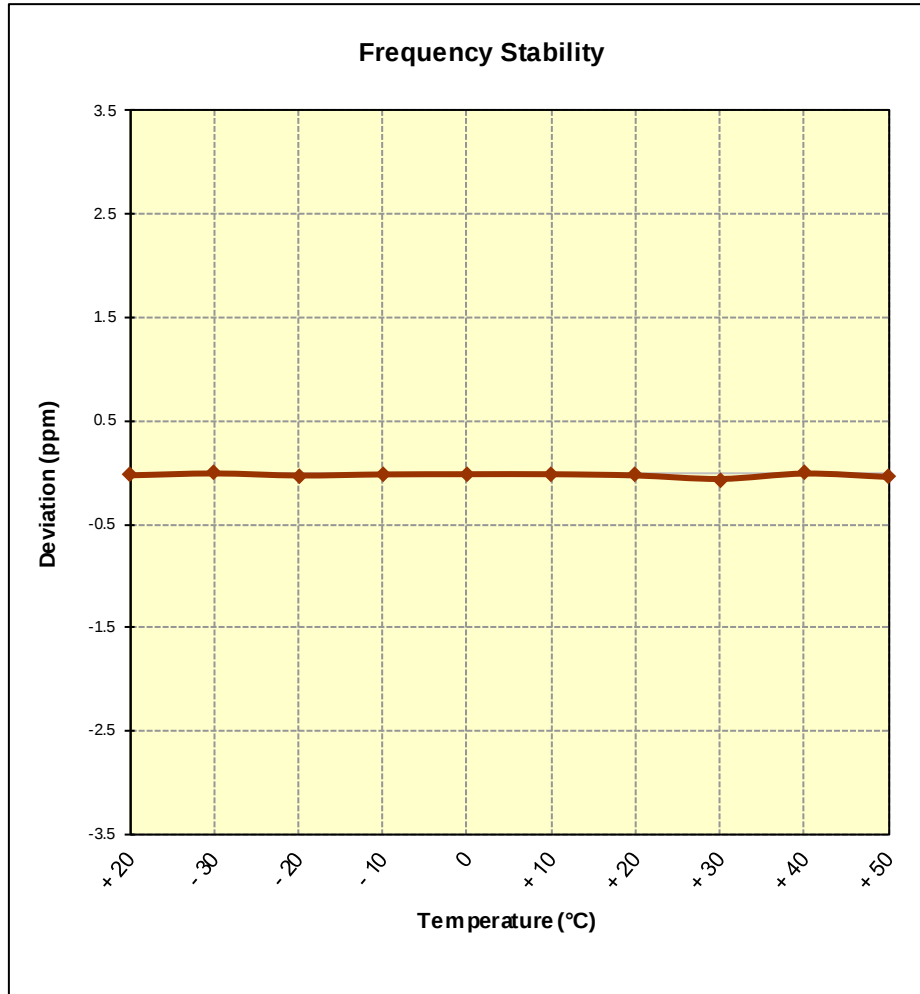


Figure 7-8. Frequency Stability Graph (Band 7)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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Band 38 Frequency Stability Measurements

§2.1055 §27.54 RSS-199(4.3)

OPERATING FREQUENCY: 2,593,000,000 Hz
 CHANNEL: 40620
 REFERENCE VOLTAGE: 3.80 VDC

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.80	+ 20 (Ref)	2,592,999,985	-15	-0.0000006
100 %		- 30	2,592,999,837	-163	-0.0000063
100 %		- 20	2,592,999,835	-165	-0.0000064
100 %		- 10	2,592,999,972	-28	-0.0000011
100 %		0	2,592,999,816	-184	-0.0000071
100 %		+ 10	2,592,999,982	-18	-0.0000007
100 %		+ 20	2,592,999,995	-5	-0.0000002
100 %		+ 30	2,592,999,800	-200	-0.0000077
100 %		+ 40	2,592,999,939	-61	-0.0000023
100 %		+ 50	2,592,999,960	-40	-0.0000016
BATT. ENDPOINT	3.40	+ 20	2,592,999,895	-105	-0.0000041

Table 7-33. Frequency Stability Data (Band 38)

Note:

Based on the results of the frequency stability test at the center channel the frequency deviation results measured are very small. As such it is determined that the channels at the band edge would remain in-band when the maximum measured frequency deviation noted during the frequency stability tests is applied. Therefore the device is determined to remain operating in band over the temperature and voltage range as tested.

FCC ID: A3LSMJ250F			FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
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Band 38 Frequency Stability Measurements

§2.1055 §27.54 RSS-199(4.3)

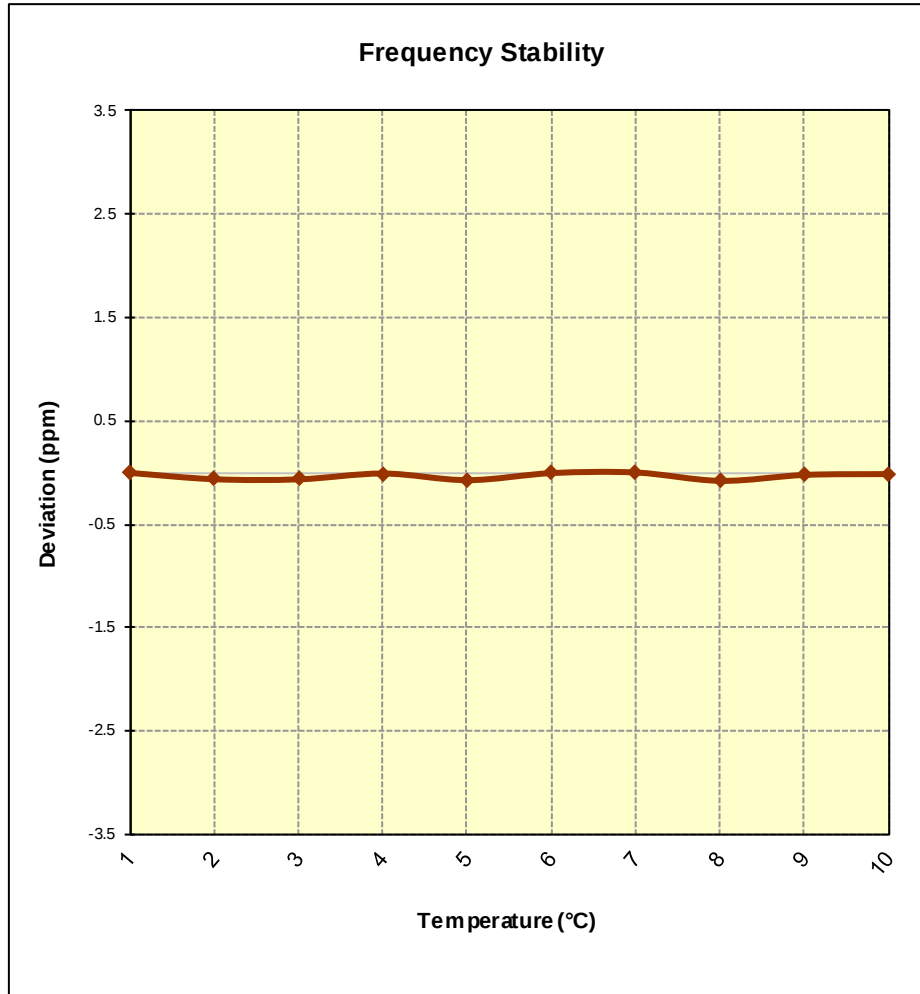


Figure 7-9. Frequency Stability Graph (Band 38)

FCC ID: A3LSMJ250F	PCTEST ENGINEERING LABORATORY, INC.	FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager
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8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSMJ250F** complies with all the requirements of Part 22 & 27 of the FCC Rules for LTE operation only.

FCC ID: A3LSMJ250F		FCC Pt. 22 & 27 LTE TEST REPORT (CERTIFICATION)		Approved by: Quality Manager
Test Report S/N: 1M1709270258-03.A3L	Test Dates: 9/27 - 10/12/2017	EUT Type: Portable Handset	Page 74 of 74	